ADVANCED SOFTWARE TEST METHODS

Detailed Notes and Viewgraphs

Presented By:

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MOTIVATIONS FOR SOFTWARE QUALITY ASSURANCE

• EFFECTIVE UTILITY

- . * Does a software system do what it is supposed to do?
 - * Does it not do what it's not supposed to do?
 - * What are its actual properties?

JUDGEMENT REQUIRED FOR QUALITY

• PERSPECTIVE OF OPINION MAKER (JUDGE)

- * Software expert
- * Software user (Engineer)
- * Public user
- * Public non-user

• WHAT IS THE COST OF A SOFTWARE ERROR?

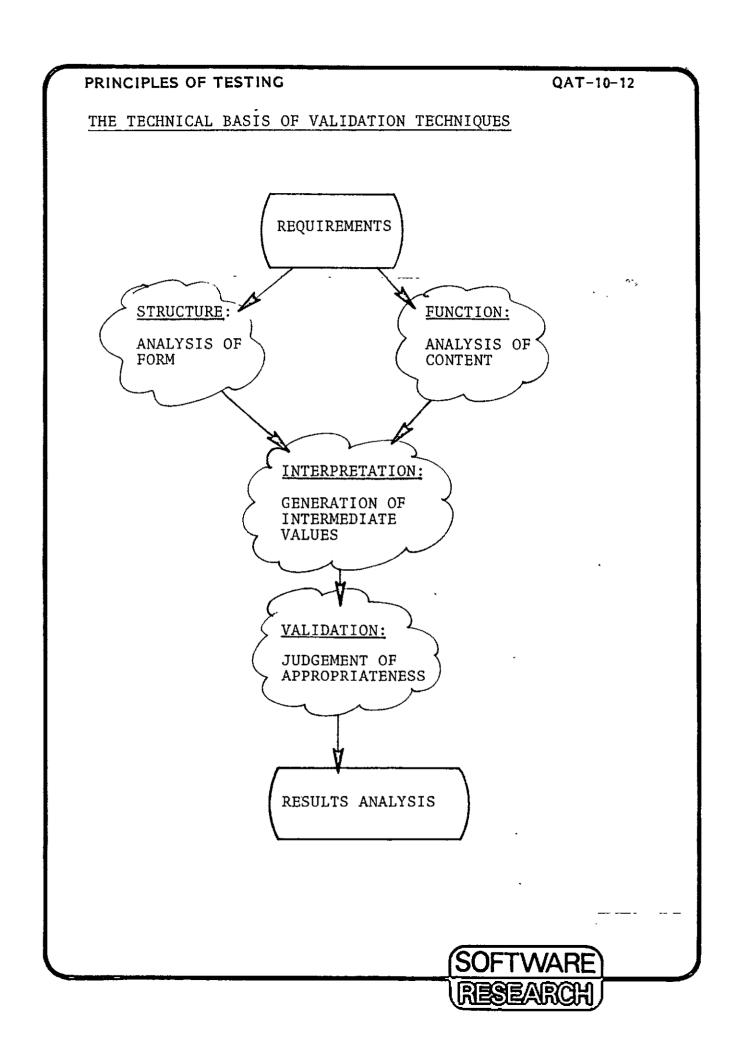
- Direct costs
- Indirect costs
- Human costs
- Liability



Comparison of Hardware and Software Complexity

	Software	Hardware
1	Simple "tr" (translate function)	A PLA or combinational circuit
2	Some mathematical operation like matrix multiply	Memory address computation logic and arithmetic
3	Language Compiler	Complete CPU (instruction inter- preter & executer)
4	Operating system	Complete Computer System (CPU, memory, input/output controllers)





SOME "PRINCIPLES" OF PROGRAM TESTING

SEPARABILITY

* Testing a thing composed of two parts can be done by testing the thing's parts.

REPEATABILITY

- * Any test of a module has to be repeatable.
- Non-repeatability implies non-deterministically.

MEASURABILITY

It doesn't do any good to do something if you can't measure the effect of what you've done.

FINITENESS

* Any test that never stops is not really a test at all.

FUNCTIONAL NECESSITY

* Every part of a software system has to have some purpose else it need not be part of the software system.

DISTINGUISHABILITY

* Two identical tests are no better than one of them.

• THE ENVIRONMENT IS PART OF THE INPUT!



TEST TECHNIQUES SURVEY

REQUIREMENTS-BASED TEST PLANNING

GOAL:

ESTABLISH TEST REQUIREMENTS FROM ORIGINAL SYSTEM REQUIREMENTS:

MODULE TEST SUBSYSTEM TEST SYSTEM (ACCEPTANCE) TEST

PROVIDE ASSURANCE OF COMPLETENESS OF TESTING

IDENTIFY MISSING/EXTRA TESTS

METHOD:

REQUIREMENTS TRACING:

LIST OF REQUIREMENT FEATURES FEATURES COVERED BY TESTS "RI" METRIC MEASURES:

MISSED REQUIREMENTS MISSING TESTS EXTRA TESTS

AFTER CREATION OF DATABASE, ANALYSIS OF INFORMATION FOR CURRENT R1 VALUE

PAYOFFS:

"EASY" METHODOLOGY, SIMPLE TOOL TO BUILD

HARD TO APPLY RELIABLY FOR BIG SYSTEMS PROBLEMS AND SOLUTIONS:

RELIES ON HUMAN INTERFACE

POSSIBLE HIGH DEGREE OF AUTOMATION (AUTOMATIC COLLECTION OF REQUIREMENTS' HIT)

LARGE DATABASE IF MODULE, SUBSYSTEM, AND SYSTEM TESTING HANDLED



CAUSE EFFECT GRAPHS AS REQUIREMENTS-BASED TEST PLANNER GOAL:

USE FIRST ORDER FORMAL LOGIC AS BASIS FOR DEFINING INPUT/OUTPUT RELATIONS

GENERATE TEST PLANS (INPUTS AND OUTPUTS) AUTOMATICALLY

METHOD:

MANUAL OR AUTOMATED SUPPORT FOR IDENTIFICATION OF INPUT AND OUTPUT STATES

MANUAL OR AUTOMATED SUPPORT FOR CAUSE EFFECT GRAPH (CEG) GENERATION

MECHANICAL GENERATION OF TESTS (PATH SENSITIZATION)

PAYOFFS:

FULLY MECHANICAL OPERATION OF CEG SYSTEM

EXTERNAL SPECIFICATIONS OF TESTOBJECT BEHAVIOR

PROBLEMS AND SOLUTIONS:

CAPACITY LIMITED TO APPROX. 75 CAUSES + EFFECTS

TOO MUCH DEPENDENCE ON USER'S CHOICE OF INPUT AND OUTPUT STATES

NO WAY TO DESCRIBE CERTAIN SOFTWARE-ESSENTIAL CONSTRUCTIONS (E.G. LOOPS)



FINITE STATE MODELS AS REQUIREMENTS-BASED TEST PLANNER GOAL:

EXTENDED MODEL OF SYSTEM AS BASIS FOR BEHAVIOR DESCRIPTION

TESTS OF MODEL BECOME ACCEPTANCE TESTS OF SYSTEM

METHOD:

MODEL EXPECTED PROGRAM BEHAVIOR WITH STATE TRANSITION DIAGRAMS

TEST ALL TRANSITIONS IN DIAGRAM

TEST ALL STATE/INPUT POSITIONS IN TABLE

PAYOFFS:

MECHANICAL TEST GENERATION, INPUT/OUTPUT DESCRIPTION

ASSURED REPRESENTABILITY OF ANY SYSTEM CONSTRUCT (WITH ASSOCIATED COMPLEXITY)

PROBLEMS AND SOLUTIONS:

BASED ON AUTOMATA THEORY: POWERFUL BUT COMPLEX TECHNIQUE

LIMITED TO PERHAPS 50-100 TOTAL STATES

CAPABILITY FOR MODEL TO HAVE "MEMORY" BUT DIFFICULT TO REPRESENT ITERATION

COMBINATORIC GROWTH IN NUMBER OF TESTS



DESIGN BASED TEST PLANNING

GOAL:

DEVISE TESTS FROM SOME PART OF EARLY SYSTEM DESIGN DESCRIPTION:

> NS CHARTS MJS CHARTS DATA DICTIONARY

OR, DESIGN TESTS FROM PDL

METHOD:

TAKE ADVANTAGE OF STRUCTURAL INFORMATION IN DESIGN

ORGANIZE STRUCTURALLY SOUND, FUNCTIONALLY ACCURATE TESTS

EXPAND BY MANUAL OR AUTOMATED ANALYSIS OF "FLOW"

PAYOFFS: -

CERTAINTY OF COMPLETENESS

AUTOMATED ASSISTANCE

PROBLEMS AND SOLUTIONS:

COMBINATORICS MAY BE A LIMITING (WITH OR WITHOUT AUTOMATION)

ESSENTIAL LINK TO "EXTERNAL SPECIFICATION" MAY BE LACKING



TEST PLANNING FROM PDL OR FROM LIVE CODE

GOAL:

EXPLOIT EXISTING STRUCTURAL INFORMATION IN PDL, OR IN CODE, TO ASSIST IN TEST PLANNING

METHOD:

CONSTRUCT DIGRAPH FROM STRUCTURED OBJECT

REDUCE DIGRAPH TO DESCRIPTIONS OF INTERNAL STRUCTURE (HIERARCHICAL DECOMPOSITION)

DERIVE COMPREHENSIVE AND COVERING TEST SETS

USE PATH DESCRIPTIONS TO PLAN TESTS

PAYOFFS:

MAY BE CONNECTED TO PROGRAMMING TASK

POSSIBLE AUTOMATIC SELECTION OF INPUT/ OUTPUT INFORMATION

UNAMBIGUOUS OUTPUTS

PROBLEMS AND SOLUTIONS:

TESTING ONLY STRUCTURE, NOT FUNCTIONS

USE WITH HIGH-LEVEL BEHAVIOR MODELS ONLY?



INSPECTION/REVIEW TECHNIQUE AUTOMATION

GOAL:

SUPPORT INSPECTION METHODS FOR DESIGN, TEST PLANS, AND PROGRAM CODE

METHOD:

PROVIDE AUTOMATED SUPPORT DURING INSPECTION PROCESS

ASSISTANCE IN APPLYING RULES

POSSIBLE MECHANIZATION IN DESIGNING AND/OR PRESENTING RULES

ASSISTANCE IN RECORDKEEPING

ASSISTANCE IN RE-INSPECTION

PAYOFFS:

INCREASED PRODUCTIVITY

INCREASED ACCURACY, REPEATABILITY

PROBLEMS AND SOLUTIONS:

INTERJECTION OF "MORE MACHINERY" INTO ALREADY LABOR-INTENSIVE SITUATION

HAVE A "PC" IN THE INSPECTION LOOP TO ACT AS SECRETARY

POSSIBLE "EXPERT SYSTEM" APPLICATION



STATIC TESTING

GOAL:

APPLY STATIC TESTING (SOURCE BASED)
METHODS TO CANDIDATE SOFTWARE

METHOD:

REQUIRES SPECIAL STATIC ANALYZER SYSTEM

ALLEGATION SET MUST BE CHOSEN CAREFULLY

ALLEGATIONS MUST BE BASED ON EXPERIENCE WITH REAL-WORLD AREAS

PAYOFFS:

AFTER INITIAL CAPITAL COST, VERY HIGH RETURN (VERY LOW COST/DEFECT)

REPLACES PROGRAMMERS' ATTENTIVENESS

PROBLEMS AND SOLUTIONS:

AUTOMATED METHOD MAY BECOME A CRUTCH FOR PROGRAMMER/ANALYST

LANGUAGE DEPENDENT SYSTEM, RULESET POSSIBLE EXPERT SYSTEM APPLICATION?



DYNAMIC MODULE TESTING -- TEST CAPTURE/PLAYBACK GOAL:

PROVIDE AUTOMATED CAPTURE OF ACTUAL TEST SESSIONS

ASSURE AUTOMATIC, 100% PERFECT, SESSION PLAYBACK

METHOD:

INTERCEPT TESTERS' KEYBOARD ACTIVITY

INTERCEPT SCREEN ACTIVITY (USUALLY ON TESTERS' COMMAND)

GENERATE SUPPORTING KEYSAVE FILES THAT CAN BE PLAYED BACK

PAYOFFS:

STRONG BASE FOR REGRESSION TESTING

ASSURED REPEATABILITY OF TESTS

POSSIBLE KEYSAVE FILE EDITING (FOR INCREASED SIMPLICITY, EFFICIENCY OF KEYSAVE FILES)

PROBLEMS AND SOLUTIONS:

TIMING AMBIGUITIES CAN ALTER TEST
BEHAVIOR -- USE FAITHFUL TIME RECORDING

DATA VOLUME IS SUBSTANTIAL IF TOO MANY SCREEN IMAGES ARE SAVED



DYNAMIC MODULE TESTING -- TEST COMPLETENESS ANALYSIS GOAL:

ASSURE A COMPREHENSIVE TEST SET, ACCORDING TO SOME REPEATABLE MEASURE

"CONVERGENCE TESTING" TO COMPLETE, DIVERSIFY TEST SET

METHOD:

TEMPORARY SOURCE PROGRAM INSTRUMENTATION

RUNTIME DATA COLLECTION (POSSIBLY INTERACTIVE)

POST-TEST DATA REDUCTION, NOT-HIT ANALYSIS

PAYOFFS:

LOW COST METHOD

IDENTIFICATION OF UNDER TESTED REGIMES

HIGH AVAILABILITY OF TEST TOOLS

PROBLEMS AND SOLUTIONS:

DATA BURDEN CAN BE LARGE IF CARE IS NOT TAKEN IN PLANNING STAGES

TESTS ONLY STRUCTURE, NOT FUNCTIONS (STRUCTURAL TESTS MAY BE A GOOD APPROXIMATION TO FUNCTIONAL TESTS)



DYNAMIC MODULE TESTING -- TEST FILE GENERATION GOAL:

CREATION OF FILES OF TEST DATA

RIGHT FORMAT FOR TESTED PROGRAM

VARIABLE CONTENTS, USER SELECTABLE

METHOD:

TEST FILE GENERATOR SYSTEM

DESCRIPTOR FILE

VALUES FILE

INSTRUCTIONS FILE

OUTPUT PROCESSING COMBINES THREE FILES, GENERATES INSTANCES OF TEST DATA FILE

PAYOFFS:

FORCES DEFINITION OF OUTPUTS QUICKLY, EARLY IN TESTING PROCESS

CAN BE ACCOMPLISHED FROM EXISTING OUTPUT (BY EDITING)

PROBLEMS AND SOLUTIONS:

COMBINATORIC GROWTH OF NUMBER OF TESTS POSSIBLE

RANDOM SELECTION OF VALUES MAY BE DECEPTIVE. NOT PROVIDING ENOUGH COVERAGE?



DYNAMIC MODULE TESTING -- RELIABLE TEST DATA ASSESSMENT GOAL:

GIVEN A SET OF STRUCTURALLY SOUND TEST, ASSURE THE THEORETICAL RELIABILITY OF THE TEST DATA VALUES

METHOD:

REQUIRES ANALYSIS OF SOURCE PROGRAM AND TEST SET

TESTS DATA RELIABILITY CRITERIA ARE WELL ESTABLISHED:

AT BOUNDARY VALUES

AT LIMIT VALUES

FOR ITERATIONS

NEAR "SWITCH" VALUES

UNIQUE INPUT/OUTPUT VALUES

ETC.

SHOULD BE ABLE TO IDENTIFY "UNRELIABLE" TESTS BY DETAILED ANALYSIS

PAYOFFS:

ENHANCED CONFIDENCE IN SETS OF TESTS

ELIMINATION OF USELESS OR REDUNDANT TESTS

POSSIBLE IMPLICATIONS ON NUMERICAL PRECISION

PROBLEMS AND SOLUTIONS:

RELIES TOO HEAVILY ON STRUCTURE

QUESTIONS CONCERNING NUMERIC PRECISION (ROUNDOFF, TRUNCATION, ETC.)



DYNAMIC MODULE TESTING -- TESTBED GENERATION GOAL:

CONSTRUCT UNIT TEST ENVIRONMENT AUTOMATICALLY FROM SOURCE CODE

METHOD:

SOURCE PROGRAM ANALYZER AND TEST BED GENERATOR SYSTEM:

AUTOMATIC TEST TARGET CALL GENERATED

STUBS GENERATED

GLOBAL DATA SIMULATED

USER INTERACTIVE CONTROL

CLOSE CONNECTION TO COMPILER SYSTEM

PAYOFFS:

EASES PROGRAMMING, TESTING TASKS

COVERAGE ANALYSIS POSSIBLY AUTOMATIC

STRONG CONNECTION TO INTERACTIVE DEBUG SYSTEMS

PROBLEMS AND SOLUTIONS:

INVESTMENT COST

GENERALITY (LANGUAGE, SYSTEM DEPENDENCE)

PORTABILITY

HOW TO LOCATE "RIGHT" ELEMENTS OF PROGRAM SUPPORT ENVIRONMENT



DYNAMIC INTERFACE TESTING

GOAL:

HAVE ALL THE INTERFACES BEEN FULLY TESTED

METHOD:

FULLY TESTED INTERFACE MEANS:

CONTROL VARIABLES TRIED

DATA VALUES TRIED:

INPUT OUTPUT INPUT & OUTPUT

INSTRUMENTATION OF INTERFACES ALONE

"II" METRIC MEASURES COMPLETENESS

PAYOFFS:

IMMEDIATE KNOWLEDGE OF UNEXERCISED AREAS

PROBLEMS AND SOLUTIONS:

WHAT PERCENTAGE OF ERRORS ARISE FROM THIS AREA?

CAPITAL INVESTMENT IN TOOL SYSTEM

POSSIBLE INTRODUCTION OF DATA FLOW ANOMALIES IF INTERFACE CONTROL TESTING IS NOT DONE CORRECTLY



DYNAMIC SYSTEM TESTING

GOAL:

HAVE ALL REQUIRED SYSTEM FEATURES AND FACILITIES BEEN EXERCISED SUCCESSFULLY?

METHODS:

(1) "BLACK BOX" TESTING:

SEE REQUIREMENTS BASED TESTING METHODS

(2) SOURCE LEVEL INSTRUMENTATION OF FUNCTION CALL PAIRS:

AUTOMATIC CALL-PAIR IDENTIFICATION

RUNTIME DATA COLLECTION

POST-TEST ANALYSIS OF DATA

"S1" MEASURE APPLIED TO ASSESS COMPLETENESS

PAYOFFS:

MECHANICAL VERIFICATION OF POWER, SOPHISTICATION OF TESTS

IDENTIFICATION OF FUNCTION CALL PAIRS NOT EXERCISED (RELATED TO INTERFACE TESTING)

PROBLEMS AND SOLUTIONS:

EXTRA RUNNING TIME AND SYSTEM COMPLEXITY

SIZE GROWTH OF APPROX. 10%



REGRESSION TESTING

GOAL:

HAVE ALREADY-TESTED FUNCTIONS BEEN RE-TESTED SUCCESSFULLY?

ARE NEW FUNCTIONS INTRODUCED?

ARE EXISTING FUNCTIONS DELETED?

METHOD:

ORGANIZE TESTS FOR AUTOMATIC REGRESSION EXECUTION

BUILD MATRIX IDENTIFYING STRUCTURE VERSUS TESTS WHICH EXERCISE STRUCTURE

RE-EXECUTE AND CHECK ONLY NEEDED TESTS (TYPICALLY 1%-10% OF THE TOTAL)

PAYOFFS:

POSSIBLE 10-100:1 REDUCTION IN RETESTING TIME REQUIREMENTS

SECONDARY BENEFITS FROM WELL ORGANIZED TEST DATA

PROBLEMS AND SOLUTIONS:

LARGE AMOUNTS OF TESTS DATA REQUIRED

ADDITIONAL ANALYSIS BURDEN

POSSIBLE TROUBLE HANDLING UNEXPECTED SYSTEM "ABORTS", OTHER ANOMALOUS OUTPUTS NOT EASILY AUTOMATABLE



MAINTENANCE TESTING -- CHANGE ANALYSIS

GOAL:

RELATE STRUCTURE OF CHANGES IN PROGRAM TO NEEDED RE-TESTING

METHOD:

IDENTIFY "STRUCTURE UNIT" THAT IS KNOWN TO CONTAIN ALL OF THE CHANGE:

ADDITION (+)

DELETION (-)

MODIFICATION (0)

IDENTIFY TESTS WHICH ENTER/EXIT THE AFFECTED REGION

PAYOFFS:

VERY EFFICIENT RE-TESTING SCHEME

DETAILED KNOWLEDGE OF SYSTEM STRUCTURE AVAILABLE

PROBLEMS AND SOLUTIONS:

MAY BE TOO DETAILED IF SYSTEM IS LARGE

MAY BE UNNEEDED IF SYSTEM IS SMALL

MAY REQUIRE TOO MANY TESTS

NOT NECESSARILY RELATED TO FUNCTIONAL TESTING



LANGUAGE VALIDATION TESTING

GOAL:

IDENTIFY PROBLEMS IN COMPILER

METHOD:

FULL VALIDATION -- USE VALIDATION SUITE

PARTIAL VALIDATION -- APPLY SELECTED PARTS

TOUCH-TEST VALIDATION -- ASSURE REQUIRED BEHAVIOR OF ALL FEATURES ONE-BY-ONE

SANITY TESTING -- SIMPLE "COHERENCE" TESTING

PAYOFFS:

PACKAGED SUITES READILY AVAILABLE

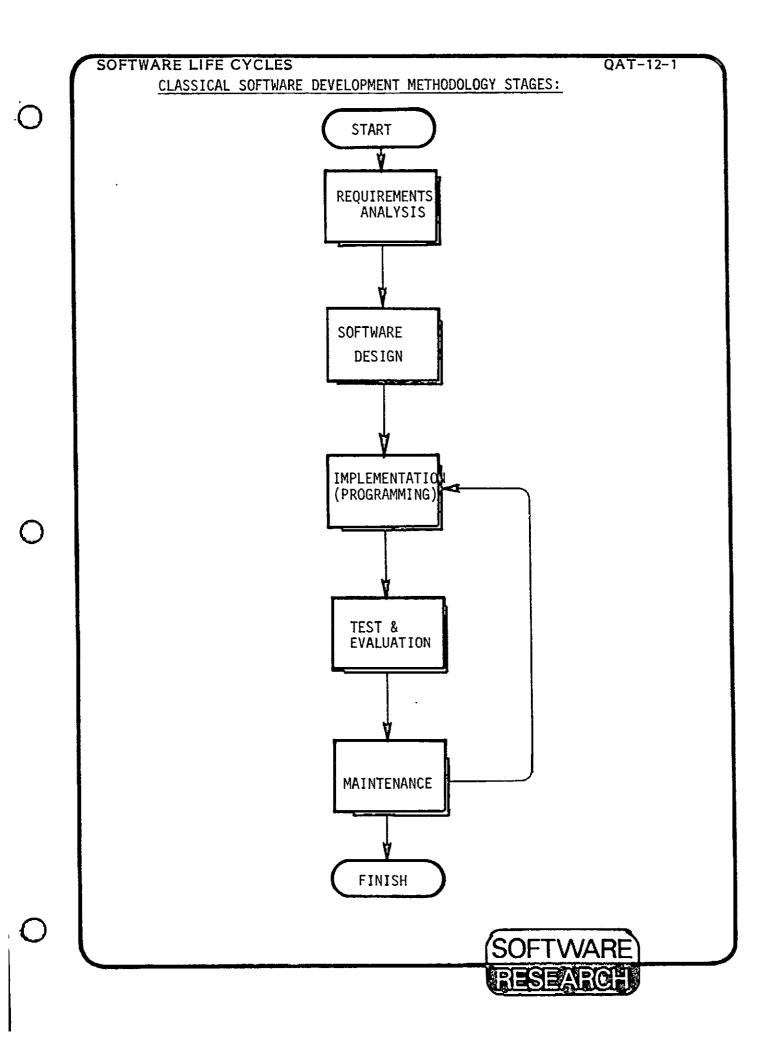
MOST LANGUAGE ANOMALIES IDENTIFIED EARLY

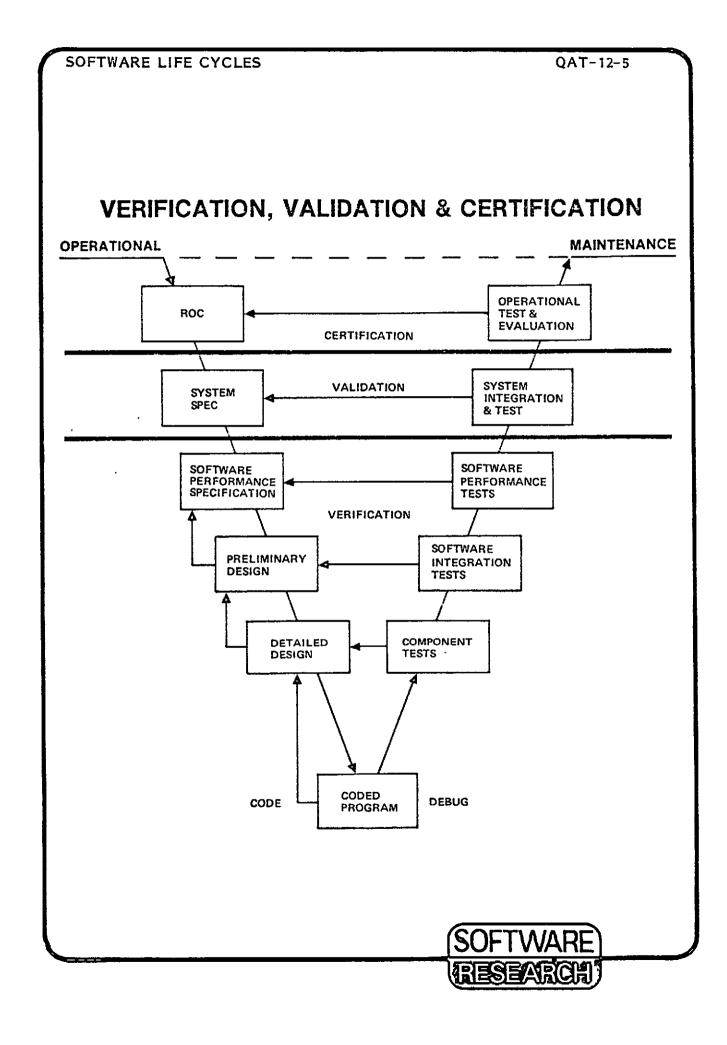
SUBTLE DEFECTS DISCOVERED

PROBLEMS AND SOLUTIONS:

NOT NECESSARILY STRONG STRUCTURAL TESTS
LENGTHY TO ACCOMPLISH EVEN FOR SIMPLE,
WELL KNOWN COMPILERS

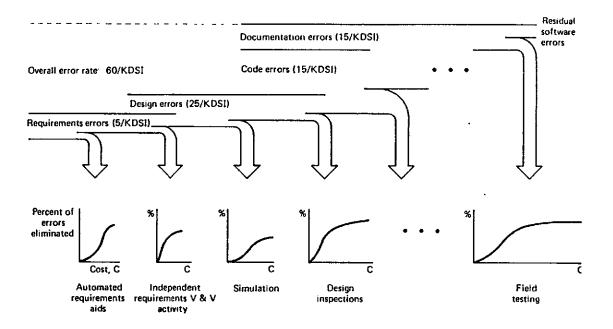






SOFTWARE LIFE CYCLES QAT-12-10

THE BASIC SOFTWARE ERROR INTRODUCTION/REMOVAL MODEL



Source: Boehm, Software Engineering Economics, 1982



ERROR	ANA	LYSIS
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ERROR CATEGORY

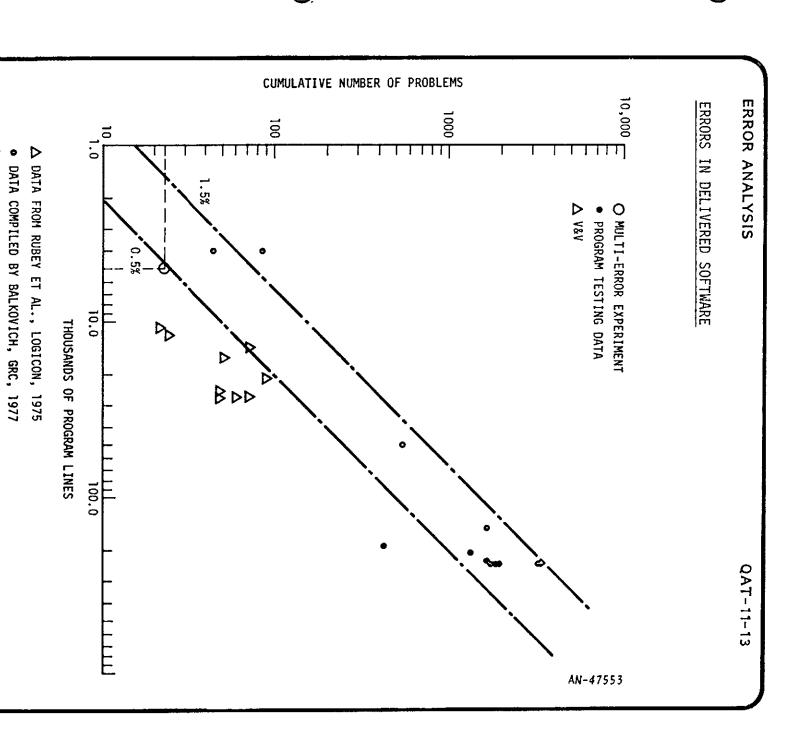
QAT-11-3

A100 Incorrect operand in equation A200 Incorrect use of parenthesis A300 Sign convention error A400 Units or data conversion error A500 Computation produces an over/under flow A600 Incorrect/inaccurate equation used A700 Precision loss due to mixed mode A800 Missing computation A900 Rounding or truncation error B000 LOGIC ERRORS B100 Incorrect operand in logical expression B200 Logic activities out of sequence B300 Wrong variable being checked B400 Missing logic or condition tests B500 Too many/few statements in loop B600 Loop iterated incorrect number of times (including endless loop) B700 Duplicate logic C000 DATA INPUT ERRORS C100 Data read with incorrect format C200 Incorrect input bus protocol C300 Data read from wrong device/file Data read to wrong location DATA HANDLING ERRORS D100 DATA CULTURE ERRORS	A000		COMPUTATIONAL ERRORS
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D400 Variable referred to by the wrong name (A100?) D500 Bit manipulation done incorrectly D550 Scaling error D600 Incorrect variable type D700 Data packing/unpacking error D800 Sort error D900 Subscripting error	_		Variable used as a flag or index not set properly
D550 Scaling error D600 Incorrect variable type D700 Data packing/unpacking error D800 Sort error D900 Subscripting error			Variable referred to by the wrong name (A100?)
D600 Incorrect variable type D700 Data packing/unpacking error D800 Sort error D900 Subscripting error	ı		Bit manipulation done incorrectly
D700 Data packing/unpacking error D800 Sort error D900 Subscripting error	ŧ		
D800 Sort error D900 Subscripting error			
D900 Subscripting error			
·			
BOOK DATA COTTOT ENGOS	E000	`	DATA OUTPUT ERRORS
E100 Data output to wrong device	t	=100	Data autout to summer desites
E100 Data output to wrong device E200 Data output in wrong format			
E300 Incorrect output bus protocol			Incorrect output bus protocol
E400 Data read from wrong location			Data read from wrong location



F000	INTERFACE ERRORS
F100 F200 F300 F400 F500 F600	Wrong subroutine called Call to subroutine not made or made in wrong place Subroutine arguments not consistent in type, units, order Subroutine called is nonexistent Software/data base interface error Software/software interface error
G000	DATA DEFINITION ERRORS
G100 G200 G300 G400	= = , = : = =: :::=== = = = : = : = : = =
H000	DATA BASE ERRORS
H100 H200 H300	· · · · · · · · · · · · · · · · · · ·
J000	OTHER .
J100 J200 J300 J400	Cycle time limit exceeded Memory storage limit exceeded Wrong data states at time of concurrent voting Timing error between I/O and CPU; I/O synchronization





Reference:

Gannon, et.

al.,

"Experimental Evaluation of Software Testing,"

SOFTWARE

O MULTI-ERROR EXPERIMENT, GRC, 1979

ERROR ANALYSIS QAT-11-9

EFFECT OF MODULARIZATION ON ERROR RATES

Number of Modules in System

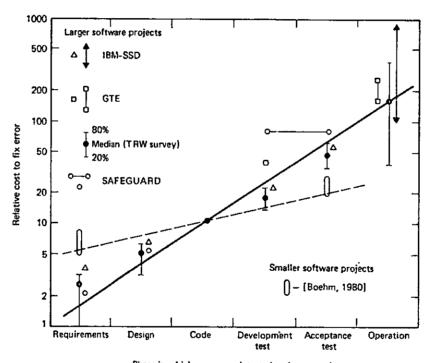
Number of Lines of Executable Code 1 2 5

100 1.75% 1.60% 1.30% 1.000 2.43% 2.22% 1.95% 1.0000 3.17% 2.94% 2.65%

<u>Citation</u>: M. Lipow, "Number of Faults Per Line of Code," <u>TEEE Trans</u>. Software Engineering, Vol. SE-8, No. 4, July 1982.



COCOMO DATABASE REPRESENTATION OF COST-TO-FIX OR CHANGE SOFTWARE THROUGHOUT LIFE CYCLE



Phase in which error was detected and corrected

SOURCE: Boehm, Software Engineering Economics, Prentice-Hall, 1981.



CODE INSPECTION METHODS

ORIGIN OF CODE INSPECTIONS

"Structured Programming" and allied software engineering technologies of the 1970's

ESSENTIAL ELEMENTS OF CODE INSPECTION

- Independent view of quality of software
- Typical inspection team has various roles:

MODERATOR - coach or key person
DESIGNER - someone who understands the software
CODER - person who wrote the program

TESTER - person responsible for testing the program

- * LOGIC: Missing, Wrong, and Extra Segments
- * PREDICTED TESTING BEHAVIOR: Common branches taken?
- * INTERCONNECTION: All links checked?

• TYPICAL RESULTS

TYPICAL RULES

- * 80% of available error population round per inspection cycle
- * 82% found during non-dynamic test; 18% found with unit test data
- Rates range between 539 and 898 NCSSs per hour for design review and first code inspection.

REFERENCE: M. E. Fagan, "Design and Code Inspections to Reduce Errors in Program Development," *IBM Systems Journal*, 1976.



ASSEMBLER LANGUAGE INSPECTION RULES (CONTINUED)

Data Area Specifications:

- 11. Check that DSECTs correspond in format to the data which they represent.
- 12. If modifications have been made to a data structure, e.g., addition of fields within the structure (control block), check that required alignments are still preserved. Use particular care in the case of control blocks iteratively generated via conditional assembly logic.

Even if the first block is OK, subsequent blocks may not start on the same type of boundary, causing program failure only when operating on blocks other than the first.

Preferred Coding Standards:

- 13. Insure that extended mnemonics are used whenever possible rather than hand coded condition code masks.
- 14. Check that a save area exists if required and is set up according to the prevailing operation system conventions (e.g. forward or backward pointers, etc.). If available, a system macro should be used to establish save area linkages (e.g. the OS SAVE macro).
- 15. Check that register usage conforms to the prevailing standards applicable to the project, if any. If no special standards are in use, then operating system standards should be applied (e.g., for OS, R13 is the save area pointer; R14 the return address; R15 the entry point address; R1 the parameter list pointer; R10 and R11 the parameter registers).
- 16. Check that EQUATEs are all meaningfully defined; in particular, check that register EQUATEs such as "R5 EQU 5" are not redefined as a short cut method of introducing changes, as would be the case if the above example were changed to "R5 EQU 6" in order to free register 5, assigning its current use to register 6.
- 17. Check that instruction level documentation adds meaning to the code, for example in the instruction "SR R5,R5 ZERO R5", the comment "ZERO R5" adds nothing to the content of the instruction. Compare: "SR R5,R5 ASSUME NO REQUESTS PENDING".

ASSEMBLER LANGUAGE INSPECTION RULES

Base Registers and Addressability:

- 1. Check that base registers defined by USINGs are all loaded at the appropriate time, i.e. before first attempted use.
- Check that all temporary base registers are DROPped when no longer needed.
- Check to ensure that base registers cannot be destroyed during execution particularly via calls to subroutines or across CSECT boundaries.
- 4. Check that all intended entry points are defined by ENTRY statements. Use the External Symbol Table Dictionary to verify their external status.
- 5. Check for operation code misspellings that will nevertheless be accepted by the assembler because the misspelling is another valid assembler instruction for which the operands have the same format as the intended instruction.
- Check that Load Multiple (LM) picks up the desired sequence of full words and that they are placed into the expected registers.
- Check that loop control mechanisms (BCT/BCTR, BXLE, BXH) do not cause looping one more time than expected, or one less.
- 8. Ensure that CLI is not used when TM is really required, i.e., check that bit switches are not confused with byte switches.
- Check that the EX instructions are set up correctly, in particular in the case of a variable length move operation (MVC subject instruction). that I less than the length desired for the move be loaded into the first operand register of the EX.
- 10. Check that register 2 has not been unwittingly destroyed by a TR (translate) or (TRT Translate and Test) instruction.



ASSEMBLER LANGUAGE INSPECTION RULES (CONTINUED)

Miscellaneous:

- 18. Check that expressions representing lengths are specified correctly.
- 19. Check that all possible cases of conditional assembly parameters are generating the code that is expected. An assembly should be produced for all major cases and the logic of each compared with a card image printout of the source statements.
- 20. Check system macro calls to insure that keyword parameters are not specified as positional parameters, and vice versa.

For macros accepting mixed format (i.e. both positional and keyword parameters) a keyword parameter written in positional form might be accepted as meaning something else than intended.

SOURCE: IBM TR 21.630m 3 May 1976



INSPECTION	3	REVIEW	FORMS

QAT-22-7

							-
CODE INSPECTION MODULE DETAIL REPORT							
				- [Date _		×10-1
Module:	Component/Application						
	MAJOR		MINOR			TOTAL	
	M	w	E	M	w	E	
LO: Logic							
TB: Test and Branch							
EL: External Linkages							-
RU: Register Usage	<u> </u>				ļ		
SU: Storage Usage	<u> </u>						
DA: Data Area Usage	<u> </u>						
PU: Program Language Usage	<u> </u>						
PE: Performance	 -						
MN: Maintainability	-	_					
DE: Design Error		ļ .	-				
PR: Prologue	 						
CC: Code Comments	1			-	<u> </u>		
OT: Other	-	<u> </u>			<u> </u>	<u> </u>	
TOTAL							
REINSPECTION REQUIRED? (Y or N)	_						



			SUM	MARY	INSPECTI	ON RE	POF	T	(NIT)	AL DE	ESIGN		DETA	ILED	DESI	GN 🗀 C				
'o: Des	ign man	ager		_						Deve	lopme	nt ma	nager							
ubject:	înspe	ction rep	ort for										Inspe	ction	date_					
	Appli	cation																		
	Comp	onent(s)																·····		
			Wor Initial		rmed By Detailed			Inspection Person-Hours (X.)									urs (X,X)			
		Full	Designer		Designer		ELOC/NCSS Actual								Esti	mated]			
Module	New or	or Part	Detailed Designer		Programme	er 🖂	E	st. Pre	Added, Modified, Do				eleted Rework			Over- view &	Insp.	Re-	Follow-	
Name	Mod.	Insp.	Programm		Tester		Α	М	D	A	М	D	Α	M	D	Prep.	Meetg.	work	, nb	Component
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leinspec	tion req	uired?		Lengt	h of inspect	tion (cl	ock !	hours	and te	nths)										
Reinspec	tion by	(date)		Additi	ional modu	les														
SCR ID																				
יטו אטכ	s writter																			
Problem	summar	y: M	ajor		Minor			Tota	ı		,									
Frors in	changed	d code:	Major	Mi	nor		_ E	rrors i	n base	code	: M	ajor_		Mino	or					



CODE INSPECTION ERROR ANALYSIS

		E	rror Categor	Total			
Erro	т Туре	Missing	Wrong	Extra	Errors	Error %	
CC DA DE EL LO	Code Comments Data Area Usage Design Error External Linkages Logic	5 3 31 7 33	17 21 32 9 49	1 1 14 3	23 25 77 19 92	6.6 7.2 22.1 5.5 26.4	
MN OT	Maintainability Other	5	7	2	14	4.0	
PE PR	Performance Prologue	3 25	2 24	5 3	10 52	2,9 14,9	
PU RU	Prog. Lang. Usage Register Usage	4	9 2	1	14 6	4.0 1.7	
SU TB	Storage Usage Test and Branch	1 2	8 5		9 7	2.7 2.0	
		123	185	40	348	100.0	



STATIC ANALYSIS — SYMBOLIC ANALYSIS OF PROGRAMS

GOAL

Static "Interpretation" of Program Behavior at the Programming Language Level

NOTE: This process makes a number of assumptions about the environment, the properties (primarily determinism) of the programming language behavior, and the "meaning" of results.

TECHNIQUE

- Choose a Path: This requires specifying the symbolic outcomes of some of the program predicates, in turn based on knowledge of the intended/expected program behavior.
- * Perform Symbolic Interpretation of Actions Along Chosen Path: This produces a "formula" set that describes the computation the program performs on the specified path.
- * Study Resulting Input/Output Relationship Against Specification

PROBLEMS

- Combinatorics The number of possible paths, or the path formulas in the presence of iteration become large and/or complicated, apparently exponentially with program size.
- * Logical Choices Difficult to make in practical cases.
- * Human Interaction Design How to communicate effectively to human user.
- * Others?

PROGNOSIS

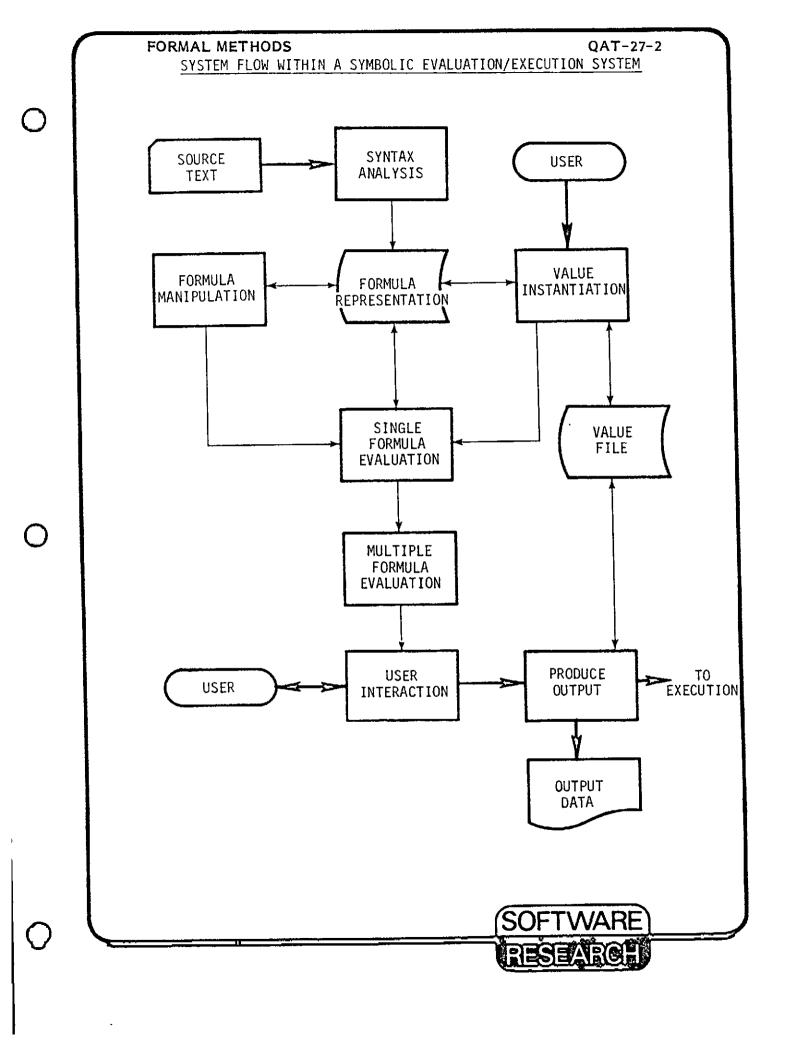
Most Promising Method, Much Research Needed.

REFERENCES:

W. E. Howden, "Symbolic Testing and the DISSECT Symbolic Evaluation System," *IEEE Trans. Software Engineering*, July 1977.

L. Clarke, Current work at University of Massachusetts





SYMBOLIC ANALYSIS APPLIED TO NUCLEAR POWER PLANT SYSTEM

• GOAL

Show how symbolic evaluation techniques can be applied now.

OUTLINE OF EXPERIMENT

- Software written in FORTRAN/IFTRAN.
- * Symbolic evaluator developed on ARPANET:
 - uses MACSYMA (a lisp-based system)
 - displays "formulas" to user
- User compares original and implemented formulas for equality.

NOTE: Differences between computed and actual formulas are mistakes. These are highly visible because special formula formatting methods are used to enhance differences.

RESULTS THUSFAR

(Final control software not yet available.)

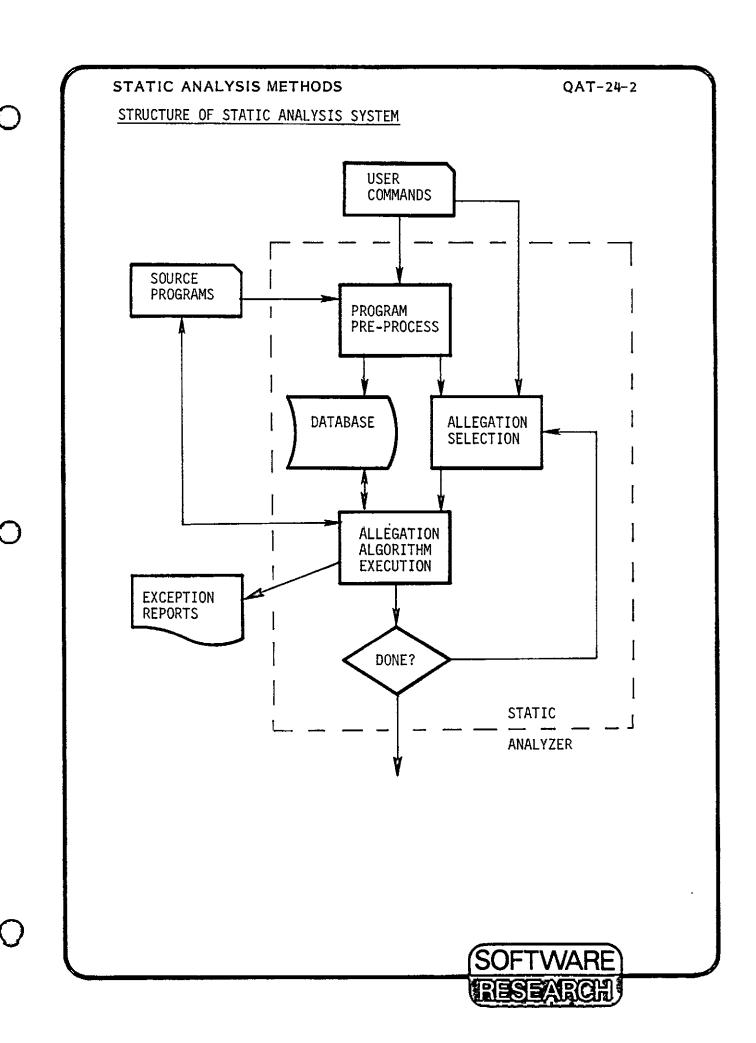
- High expectations from systematic analysis
- * Some "errors" already found in preliminary analysis

PROGNOSIS

Good results expected based on current estimates.

REFERENCE: C. V. Ramamoorthy, et. al., "A Systematic Approach to the Development and Validation of Critical Software For Nuclear Power Plants," *Proc. 1979 International Conference on Software Engineering*, Munich, West Germany, September 1979.





EXAMPLE OF UNIX/LINT STATIC ANALYZER FOR "C" PROGRAMS

```
"ald.c", line 26: warning: old-fashioned initialization: use =
"ald.c", line 186: sflag undefined
"ald.c", line 186: warning: sflag may be used before set
"ald.c", line 186: warning: sflag unused in function main
"ald.c", line 137: warning: n unused in function main
"ald.c", line 256: warning: old-fashioned assignment operator
"ald.c", line 299: warning: illegal combination of pointer and integer
"ald.c", line 651: warning: illegal pointer combination
"ald.c", line 742: warning: struct/union or struct/union pointer required
"ald.c", line 876: undefined structure or union
"ald.c", line 876: warning: illegal member use: n name
"ald.c", line 936: warning: function lookloc has return(e); and return;
_putw, arg. 2 used inconsistently
                                        "ald •c"(630) :: "ald •c"(742)
chmod returns value which is always ignored
dseek, arg. 1 used inconsistently
                                        "ald ·c"(747) :: "ald ·c"(288)
enter returns value which is sometimes ignored
                                "ald.c"(911) :: "ald.c"(151)
error: variable # of args.
error, arg. 3 used inconsistently
                                        "ald.c"(911) :: "ald.c"(464)
fclose returns value which is always ignored
                                        "/usr/lib/lint/llib-lc"(74) :: "ald.c"(770)
fread, arg. 1 used inconsistently
link returns value which is always ignored
load1 returns value which is sometimes ignored
                                        "ald •c"(926) :: "ald •c"(613)
lookloc, arg. 1 used inconsistently
mget, arg. 1 used inconsistently
                                        "ald •c"(709) :: "ald •c"(247)
                                        "ald •c"(735) :: "ald •c"(493)
mput, arg. 1 used inconsistently
signal returns value which is sometimes ignored
tget returns value which is sometimes ignored
unlink returns value which is always ignored
```



A "TYPICAL" COST/BENEFIT ANALYSIS FOR STATIC ANALYSIS

- FACES has uncovered approximately 1 "error" per 200 FORTRAN statements in NASA/Huntsville application.
- Conservatively it costs \$10 per statement to bring software to the point where it can be processed by a static analysis system.
- It is estimated to cost \$100 to repair a mistake using manual methods (once it is found).
- FACES costs approximately 10 cents per statement in a commercial environment.
- Typical Situation†:
 - * 20,000 statement program
 - * FACES discovers 100 errors at a cost of \$2000
 - Manual identification/repair would cost \$10,000
 - Manual repair (new statement rates) would cost \$1000
 - * Saving is: \$10,000 \$(\$2000 + \$1000) = \$7000
 - Implication: Using faces at a cost of \$2000 results in a \$7000 savings
 - * Benefit(saving)/cost = 3.5

† SOURCE: Wendel & Kleir, FORTRAN Error Detection Through Static Analysis, 1977.



STATIC ANALYSIS — PROGRAM PROVING METHODS

• GOAL

Mathematical approach to "proving" the correspondence between a program and its formal specification.

TYPES OF CORRECTNESS

- * Total Correctness
- * Partial Correctness
- Path Correctness

TECHNIQUE

- Define set of verification conditions.
- Prove consistency, using contradiction proof method, that the verification is consistent with program and all other assumptions.

ASSUMPTIONS

- Environment
- Programming Language
- * Operating System
- Validity of Proof

NOTE: Some programs proved correct in the literature have been shown to actually contain errors.

NOTE: Failure of Proof Method can be due to failure in prover, verification conditions, environment understanding, etc.

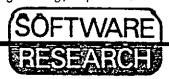
LARGEST PROGRAMS PROVED

- 1700 NCSS Assembly Language Interpreter, 43 errors
 NOTE: Approximately 85% of these errors could be found with simpler testing methods.
- USC/ISI's "PROVE OFF", seeking thorough proof of 2000 NCSS System.
- Typical cost \$50 \$500/NCSS is expected range.

REFERENCES:

S. L. Hantler and J. C. King, "An Introduction to Proving Correctness of Programs," ACM Computing Surveys, September 1976

S. L. Gerhart and L. Yelowitz, "Observations of Fallibility in Applications of Modern Programming Methodologies," *IEEE Trans. Software Engineering*, Sept. 1976



LEVELS OF SOFTWARE TEST PLANNING

• REQUIREMENTS BASED TEST PLANNING

- * Requirements analysis
- Test plans
- * Requirements coverage

• EARLY-DESIGN BASED TEST PLANNING

- Test plans
- Documentation strategy

DESIGN/PSEUDOCODE BASED TEST PLANNING

- * Operates from design embryo
- · Takes advantage of existing structure
- * Automatable function

CODE BASED TEST PLANNING

- * White box testing
- * Black box testing
- Gray box testing



STRUCTURED TESTING QAT-31-1 REPEAT CASE OF ()
CASE () CASE () CASE () d END CASE b CASE OF () CASE () CASE () g CASE () END CASE UNTIL () IF () CASÉ OF () CASE () CASE () CASE () END CASE S m ELSE CASE OF () CASE () p CASE ()

SOFTWARE

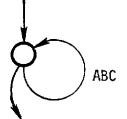
CASE ()

END CASE

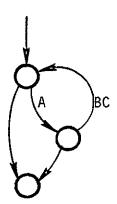
END IF

IMPACT OF AN ESCAPE STATEMENT

(1) WHILE WITHOUT ESCAPE



(2) WHILE WITH ESCAPE





STRUCTURED TESTING

QAT-31-10

PROGRAM DECOMPOSITION PRIMITIVES

Succession:

A B

Alteration:

IF (p)

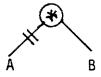
ELSE

ENDIF

Iteration:

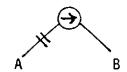
WHILE (p)

A ENDWHILE



Invocation:

CALL A(...)

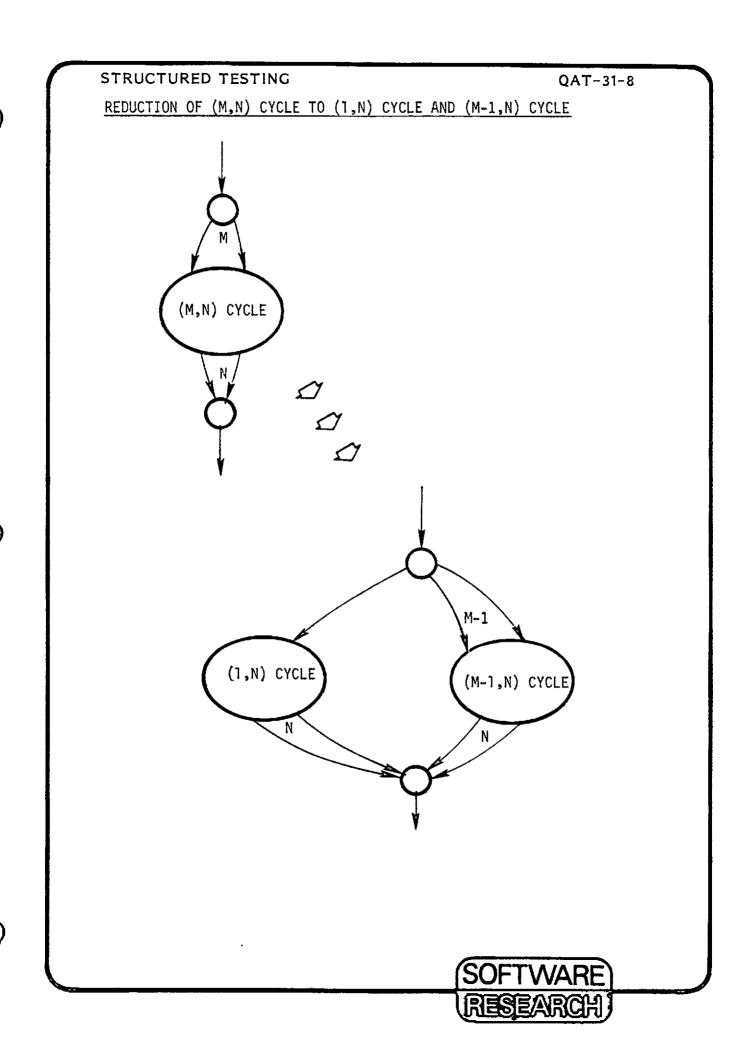




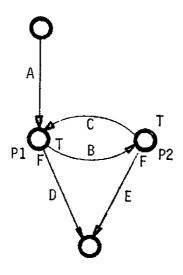
REDUCTION TECHNIQUES FOR (M,N) CYCLES

- Any digraph can be reduced to a form that involves only (1,1) cycles.
- It may be necessary to add edges and nodes.
 - * Repeated Statements
 - * Duplicated Labels
- Basic Algorithm
 - * Reduce (M,N) cycle to (M-1,N) cycle and a (1,N) cycle.
 - * This is done by copying the (1,N) cycle.
 - * Reduce a (1,N) cycle to a (1,N-1) cycle and a (1,1) cycle.
 - * This is done by "splitting" a node.
 - * Continue until only (1,1) cycles remain.





EXAMPLE OF PROGRAM INTERPRETATION/CONVERSION OF (1,2) CYCLE



```
A
tag = "TRUE"
temp = P1
WHILE ( temp AND tag )

B
IF (P2)
C
temp = P1
ELSE
tag = "FALSE"
END IF
END WHILE
IF ( tag )
D
ELSE
END IF
```

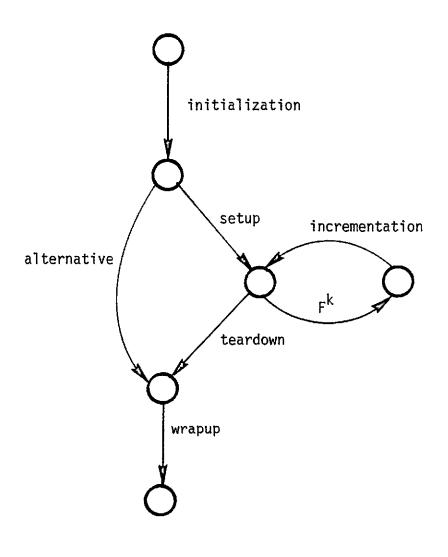
```
GENERIC EXAMPLE (CONDITIONED ITERATION)
    SUBROUTINE name ( arguments )
    declarations
    initialization
    IF ( initial-test )
          setup
          WHILE (termination-condition)
                Fk
                incrementation
          END WHILE
          teardown
    ELSE
          alternative
    END IF
    wrapup
    RETURN
    END
```



STRUCTURED TESTING

QAT-31-13

GRAPH OF CONTROL FLOW FOR GENERIC EXAMPLE (CONDITIONED ITERATION)

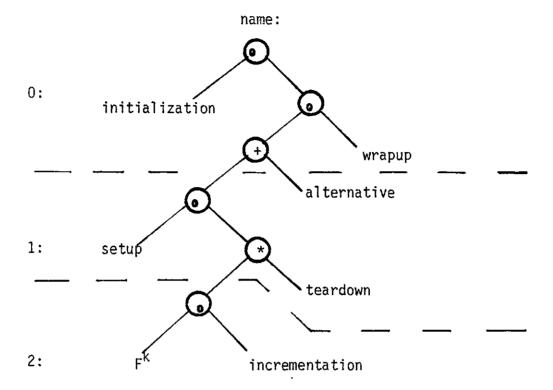




STRUCTURED TESTING

QAT-31-15

HIERARCHICAL DECOMPOSITION OF GENERIC EXAMPLE



Oth DECISIONAL LEVEL: (SEE BELOW)

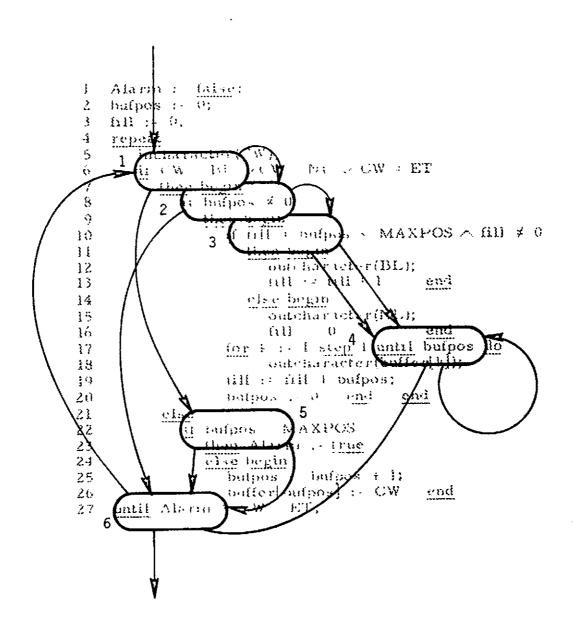
1st DECISIONAL LEVEL: TEST initialization AND alternative AND wrapup

TEST setup AND teardown

2nd DECISIONAL LEVEL: TEST F^k AND incrementation



EXAMPLE BY NAUR SHOWING DIRECTED GRAPH STRUCTURE IN OVERLAY

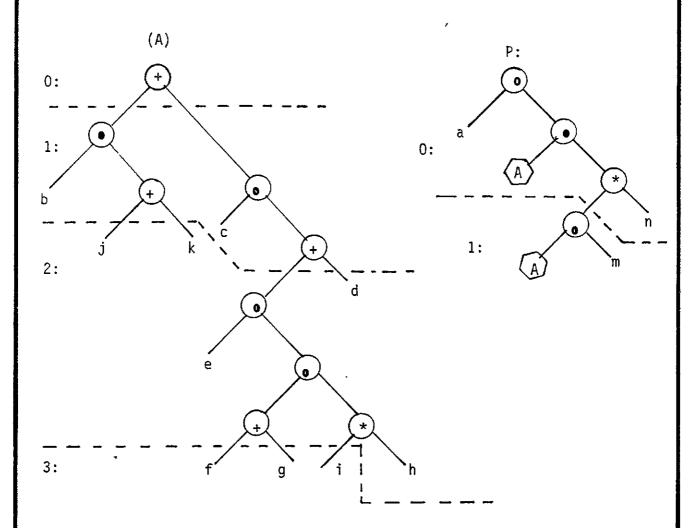


SOFTWARE RESEARCH



QAT-31-17

HIERARCHICAL DECOMPOSITION OF NAUR'S EXAMPLE



NOTES

- THE SEGMENT "A" IS COPIED ONTO THE TREE FOR P IN TWO LOCATIONS
- EACH ELEMENT OF "A" RESIDES AT TWO LEVELS OF DECISIONAL DEPTH



IMPLIED TESTING SCHEME FOR NAUR'S EXAMPLE BASED ON DECOMPOSITION TREE

- Test A in pieces in the following way:
 - * Test for j and k.
 - * Test for d.
 - * Test for f and g.
 - * Test the iteration on i.
- Test P A in the following way:
 - * Test for n.
 - * Test the iteration on A.
- Test P in the following way:
 - * Test P with A at zeroth decisional level.
 - * Test P with A at first decisional level.



IHD EXAMPLE (brfex1.*)

PATH SET:

```
1 2 9 10 25 26
1 2 9 11 (13) 12 (15 (17 18 20) 16 21 23) 14 24 25 26
1 2 9 11 (13) 12 (15 (17 18 20) 16 22 23) 14 24 25 26
1 2 9 11 (13) 12 (15 (17 19 20) 16 21 23) 14 24 25 26
1 2 9 11 (13) 12 (15 (17 19 20) 16 22 23) 14 24 25 26
1 2 9 11 (13) 12 (15 16 21 23) 14 24 25 26
1 2 9 11 (13) 12 (15 16 22 23) 14 24 25 26
1 2 9 11 (13) 12 14 24 25 26
1 2 9 11 12 (15 (17 18 20) 16 21 23) 14 24 25 26
1 2 9 11 12 (15 (17 18 20) 16 22 23) 14 24 25 26
1 2 9 11 12 (15 (17 19 20) 16 21 23) 14 24 25 26
1 2 9 11 12 (15 (17 19 20) 16 22 23) 14 24 25 26
1 2 9 11 12 (15 16 21 23) 14 24 25 26
1 2 9 11 12 (15 16 22 23) 14 24 25
1 2 9 11 12 14 24 25 24
                                             21 23) 14 24 25 26
13 (5 & 8) 40 1
                                   _0 20) 16 22 23) 14 24 25 28
13/6
                           35 (17 19 20) 16 21 23) 14 24 25 26
                 . 115) 12 (15 (17 19 20) 16 22 23) 14 24 25 26
         J. 4 9 11 (13) 12 (15 16 21 23) 14 24 25 26
- o (5 7 8) 4 9 11 (13) 12 (15 16 22 23) 14 24 25 26
1 3 (5 7 8) 4 9 11 (13) 12 14 24 25 26
1 3 (5 7 8) 4 9 11 12 (15 (17 18 20) 16 21 23) 14 24 25 26
1 3 (5 7 8) 4 9 11 12 (15 (17 18 20) 16 22 23) 14 24 25 26
1 3 (5 7 8) 4 9 11 12 (15 (17 19 20) 16 21 23) 14 24 25 26
1 3 (5 7 8) 4 9 11 12 (15 (17 19 28) 16 22 23) 14 24 25 26
1 3 (5 7 8) 4 9 11 12 (15 16 21 23) 14 24 25 26
1 3 (5 7 8) 4 9 11 12 (15 16 22 23) 14 24 25 26
1 3 (5 7 8) 4 9 11 12 14 24 25 26
1 3 4 9 10 25 26
1 3 4 9 11 (13) 12 (15 (17 18 20) 16 21 23) 14 24 25 26
1 3 4 9 11 (13) 12 (15 (17 18 20) 16 22 23) 14 24 25 26
1 3 4 9 11 (13) 12 (15 (17 19 20) 16 21 23) 14 24 25 26
1 3 4 9 11 (13) 12 (15 (17 19 20) 16 22 23) 14 24 25 26
1 3 4 9 11 (13) 12 (15 16 21 23) 14 24 25 26
1 3 4 9 11 (13) 12 (15 16 22 23) 14 24 25 26
1 3 4 9 11 (13) 12 14 24 25 26
1 3 4 9 11 12 (15 (17 18 20) 16 21 23) 14 24 25 26
1 3 4 9 11 12 (15 (17 18 20) 16 22 23) 14 24 25 26
1 3 4 9 11 12 (15 (17 19 20) 16 21 23) 14 24 25 26
1 3 4 9 11 12 (15 (17 19 20) 16 22 23) 14 24 25 26
1 3 4 9 11 12 (15 16 21 23) 14 24 25 26
1 3 4 9 11 12 (15 16 22 23) 14 24 25 26
1 3 4 9 11 12 14 24 25 26
```



STRUCTURED TESTING

QAT-31-27

IHD EXAMPLE (brfex1.*)

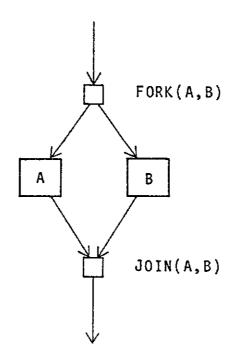
DIGRAPH:

COVER SET:

1 2 9 10 25 26 1 3 (5 6 8) 4 9 11 (13) 12 (15 (17 18 20) 16 21 23) 14 24 25 26 1 3 (5 7 8) 4 9 11 (13) 12 (15 (17 19 20) 16 22 23) 14 24 25 26

CONCURRENT PROGRAMS (FORK/JOIN PRIMITIVES)

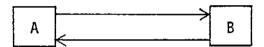
- Apply principle of separability
- Assumes call FORK/JOIN (A,B)
- Tests required are:
 - * TEST A
 - * TEST B
 - * TEST FORK(A,B)
 - * TEST JOIN(A,B)





COOPERATING PROGRAMS

- Two (or more) programs intercommunicating in a rigorous intercommunications scheme
- Test by splitting the communication paths
- Note that standard communications primitives are designed so that they survive the dislocation required by testing.









CAUSE/EFFECT GRAPH

A method for expressing the relationships between:

- * Causes: Explicit and implicit input conditions
- * Effects: Responses by the program (output conditions)

PROCEDURE

Construct a cause/effect graph (roughly) as follows:

- Identify from the program specifications all implicit and explicit causes.
 - Assumes a verbal, or at least Englishlanguage, level of specification.
 - May require detailed study.
- * Assign each cause a number.
- * Repeat for program effects.
- * Identify all relationships between causes and effects, using the potential relationships:
 - and, or, not, exor...
 - if (cause) then (effect) if (cause) then (intermediate term)
- * Draw a graph representing these relationships.
- Design tests based on a decision table representing all of the legitimate cause/effect relationships.
- Verify that all of the program predicate outcomes (C1 measure) have occurred at least once.



QAT-33-2

MYERS' EXAMPLE OF CAUSE/EFFECT GRAPHS

PROBLEM STATEMENT

3.4 The CHANGE Subcommand

The CHANGE subcommand is used to modify a character string in the "current line" of the file being edited.

3.4.1 Inputs

The syntax of the subcommand is:

C /string1/string2

String 1 represents the character string you want to replace. It can be from 1 through 30 characters long and can contain any characters except "/". String2 represents the character string that is to replace string1. It can be from 0 through 30 characters long and can contain any characters except "/". If string2 is omitted (zero length), string1 is simply deleted.

At least one blank must follow the command name "C".

3.4.2 Outputs

The changed line is printed on the terminal if the command is successful. If the change cannot be made because string1 cannot be found in the current line, the message "NOT FOUND" is printed. If the command syntax is incorrect, the message "INVALID SYNTAX" is printed.

3.4.3 System Transformations

If the syntax is valid and string1 can be found in the current line, then string1 is removed from the line and string2 is inserted in its place. The line is expanded or contracted as necessary based on the length differences between string1 and string2. If the command syntax is invalid, or if string1 cannot be found in the current line, the line is not changed.

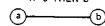


QAT-33-4

MYERS' EXAMPLE OF CAUSE/EFFECT GRAPHS

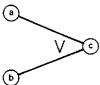
CAUSE/EFFECT RELATIONSHIPS AND REPRESENTATION

IDENTITY Function "IF a THEN b"

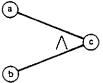


NOT Function
" IF NOT a THEN b"

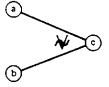
OR Function
"IF a OR b THEN c"



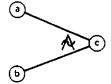
AND Function
"IF a AND b THEN c"



NOR Function
"IF NEITHER a NOR b
THEN c"



NAND Function "IF NOT a AND b THEN c"





QAT-33-5

MYERS' EXAMPLE OF CAUSE/EFFECT GRAPHS

CAUSE/EFFECT CONSTRAINTS AND REPRESENTATION

"AT MOST ONE OF a b CAN BE INVOKED"



INCLUSIVE Constraint
'AT LEAST ONE OF a, h
MUST BE INVOKED'



ONE-ONLY-ONE Constraint
"ONE AND ONLY ONE OF
B, b CAN BE INVOKED"



REQUIRES Constraint
"IF a IS INVOKED THEN
b MUST BE INVOKED"



MASKS Constraint
"EFFECT a MASKS
OBSERVANCE OF
EFFECT b"

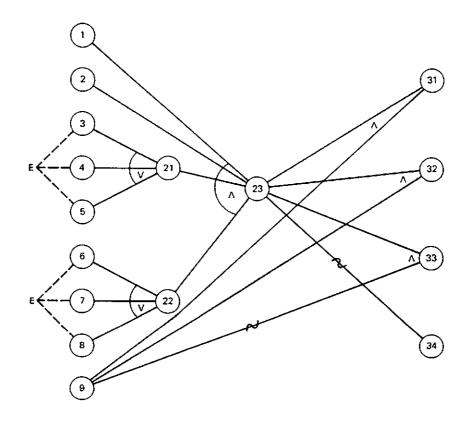




QAT-33-6

MYERS' CAUSE/EFFECT GRAPHS EXAMPLE

FINAL CAUSE/EFFECT GRAPH



CAUSES (INTERMEDIATE RELATIONSHIPS)

EFFECTS



QAT-33-7

MYERS' EXAMPLE OF CAUSE/EFFECT GRAPHS

RESULTING DECISION TABLE

TESTS

1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22

CAUSES

,		_							_													
1	1	1	l	1	1	ı	1	ı	1	1	ı	1	ı	T i	1	1	1	ī	1	Ī	ī	s
2	1	1	ı	1	1	1	,	ı	1	1	1	1	ı	ı	1	ı	1	1	ı	1	s	
3	'	1	1	s	s	s	s	s	s	ı	ı	j	s	s	s	s	s	s	s	s	s	s
4	s	s	S	ı	ı	Į,	s	s	s	s	s	s	1	ı	ı	s	s	s	s	s	s	s
5	S	5	s	s	s	S	1	ı		s	s	s	s	s	s	ı	1	1	\$	ı	1	1
6	1	s	s		s	s	1	s	s	1	s	S	1	5	s	ı	s	s	s	s	5	s
. 7	s	1	s	s	1	\$	s	ı	s	S	1	s	s	1	s	s	ı	s	s	s	s	s
8	s	s	ı	s	s	_	\$	s	ı	S	s	i	s	s	ı	s	s	1	1	s	1	1
9	1	ı	1	1	ı	1	1	1	l	s	s	s	s	s	s	S	s	s	х	х	X	х
			_																			
31	P	P	Р	Р	P	Ρ	Р	P	P	Α	Α	Α	Α	Α	Α	Α	Α	Α	Α	Α	Α	A
32	Р	Р	Р	Р	P	P	ρ	₽	Р	A	A	A	Α	A	A	Α	A	A	A	Α	Α	A
33	A	A	A	A	A	A	A	Α	A	ρ	Р	Р	ρ	ρ	Р	Р	Р	Р	A	A	Α	Α
34	Α	A	A	A	A	A	A	A	A	Α	Α	Α	Α	A	A	Α	A	Α	Р	P	Р	Р

EFFECTS

S: Suppressed

l: Invoked

X: Don't care

A: Absent

P: Present



THEORETICAL RESULTS

GOAL

State whether defects have been reliably removed by test or tests.

RELIABLE TESTING THEOREM

- * Theorem States: There are Test Data Selection Criteria such that when a program operates on a subdomain D of the entire input domain S and also meets requirements of theorem, then the program can be pre-edited to operate on all inputs.
- * Issue Is: How much less than all possible inputs is minimum needed for assurance of defect-free software?

CURRENT STATUS

- Some programs have reliable tests, some do not.
- * Under certain technical restrictions testing is known to be reliable against non-structural errors.
- Some errors are very difficult to find reliably.

NOTE: Any error must be made manifest by some combination of inputs, but the problem is to determine what that set of inputs is without encountering combinatoric limits on testing complexity.

RESEARCH METHODS

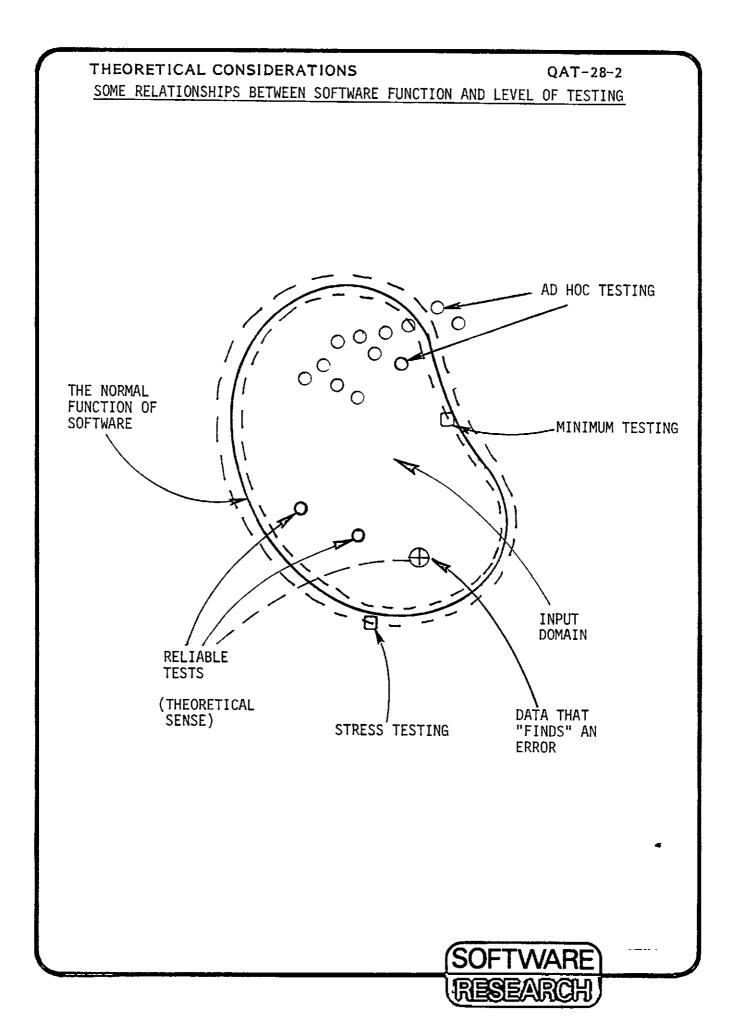
- Domain Refinement
- How data characterizes programs

REFERENCES:

W.E. Howden, "Reliability of Path Analysis Testing Strategy," IEEE Trans. Software Engineering, June, 1975.

J.B. Goodenough and S.L. Gerhart, "Toward A Theory of Test Data Selection," IEEE Trans. Software Engineering, June 1975.





THEORETICAL CONSIDERATIONS

QAT-28-3

STATEMENT TYPES AND CORRESPONDING FUNCTIONS

Statement

Functions

1. Assignment

Data access, data storage, arithmetic expression

2. Conditionals

Data access, arithmetic expression, relational expression, boolean expression

3. Loops

Loop entry functions: data access, arithmetic expression, relational expression, boolean expression

Loop exit functions: data access, arithmetic expression, relational expression, boolean expression

Index initialization: data access, data storage, arithmetic expression

Indexing: data access, data storage,
 arithmetic expression

Reference: Howden, 1980



RELIABLE TEST DATA FOR SIMPLE ERRORS IN STATEMENT FUNCTIONS

Functions

- 1. Data access
- 2. Data storage
- 3. Arithmetic expression
- 4. Relational expressions (of the form E₁ r E₂)

5. Boolean expressions (of

the form $B(E_1, E_2, \ldots, E_n)$

Reliable Test Data

Unique value for variable

New value for variable

Evaluates to non-zero quantity

Tests that evaluate E_1 and E_2 so that $E_1 < E_2$, $E_1 = E_2$ and $E_1 > E_2$; tests that evaluate E_1 and E_2 so that for

- (i) $r = \langle , \rangle$: $E_2 - E_1$ is maximal and $\langle 0 \rangle$ $E_2 - E_1$ is minimal and $\langle 0 \rangle$
- (ii) $r = >, \le$: $E_2 E_1 \text{ is minimal and } > 0$ $E_2 E_1 \text{ is maximal and } \le 0$
- (iii) $r = =, \neq:$ $E_2 E_1 = 0.$
- Tests that evaluate E_i , $1 \le i \le n$, so that all possible combinations of True and False are generated

Reference: Howden, 1980



TEST DATA GENERATION PROBLEM

• GENERAL STATEMENT

- Find test data that forces a program to execute a previously unexercised segment.
- * Choose data values automatically.
- * Unsolvable in general.

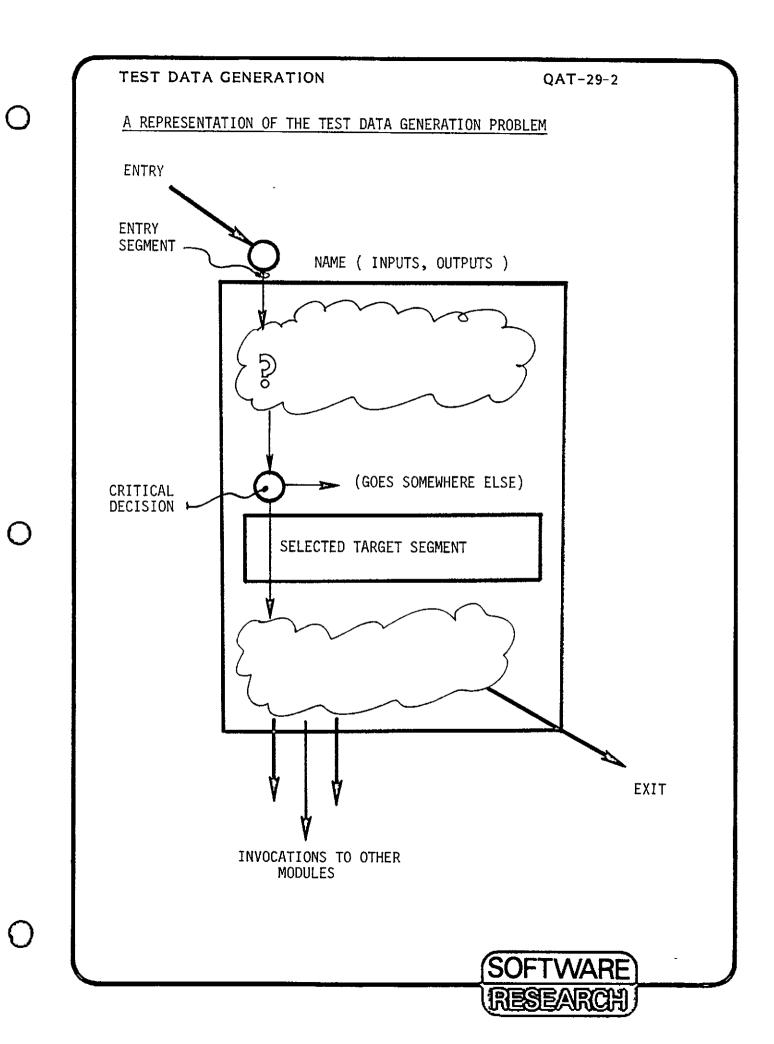
APPROACH

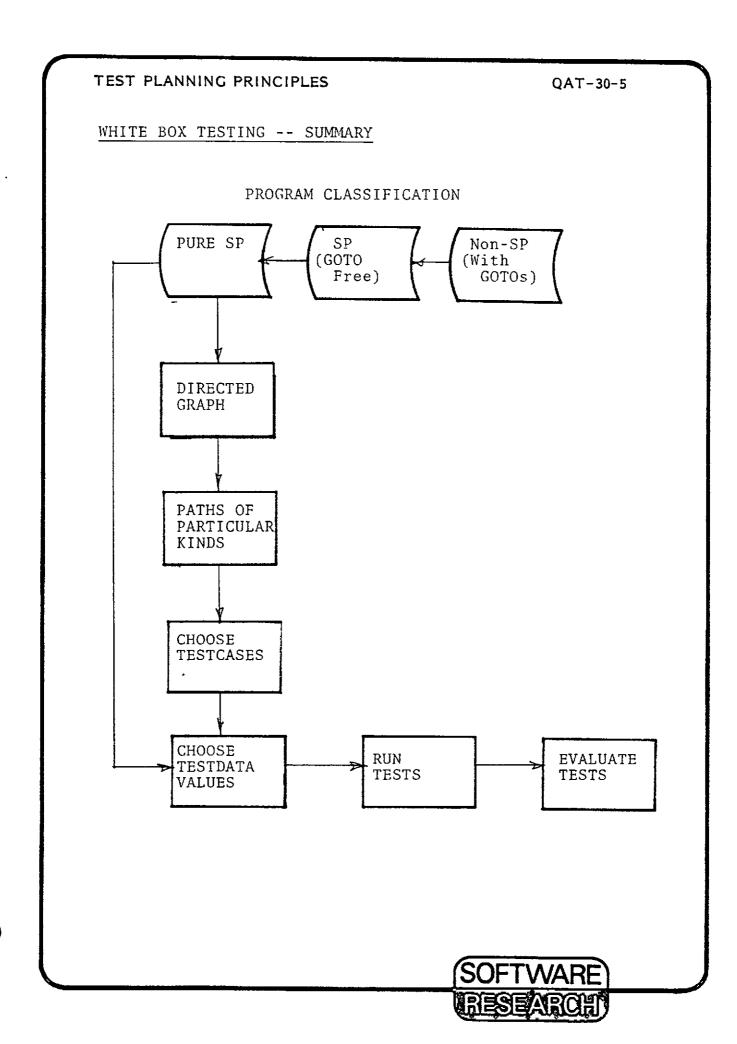
- * Choose candidate path.
- * Analyze formulas (path conditions).
- * Solve set of inequalities.

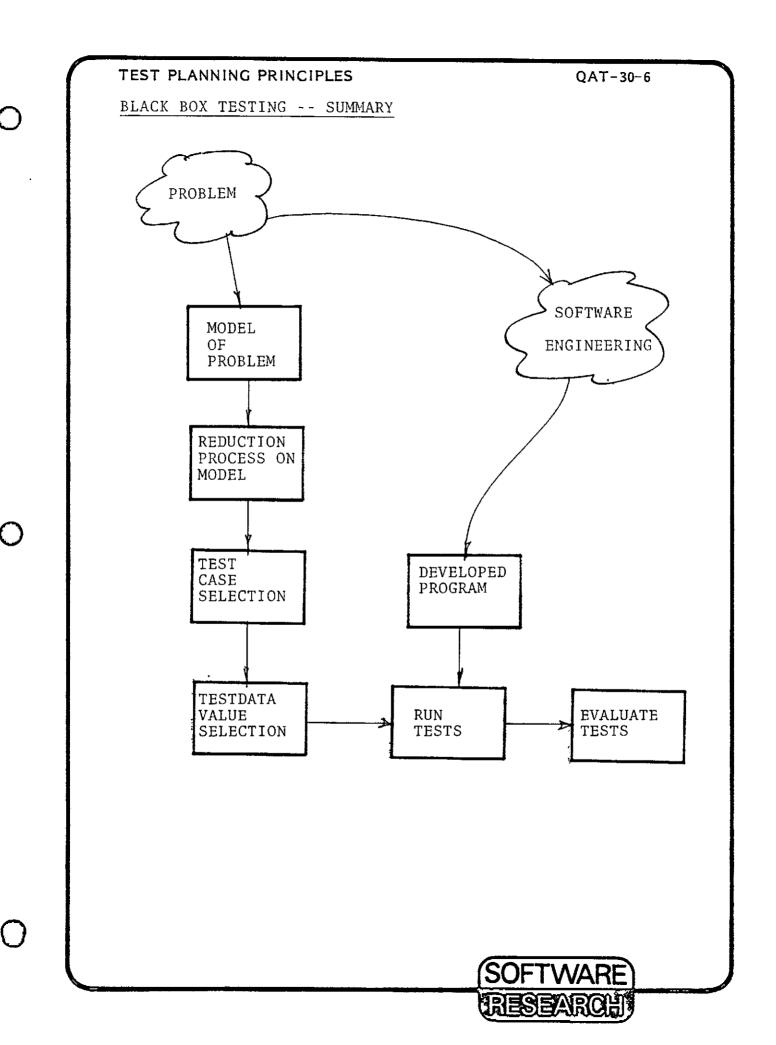
LIMITATIONS

- Combinatorics
- Complexity
- Non-Linearity









LEVELS OF TESTING METHODOLOGY

SINGLE MODULE TESTING

- Comprehensive exercise of single program(s)
- * Exhaustive investigation of behavior of module
- Maximum level of quality assurance
- * "No system is better tested than the level of testing attained for the least-tested module."

• MULTIPLE MODULE (SUB-SYSTEM) TESTING

- * Demonstration of functional behavior
- Integration of proven/tested modules into coherent subsystem
- * Localization of computational resource

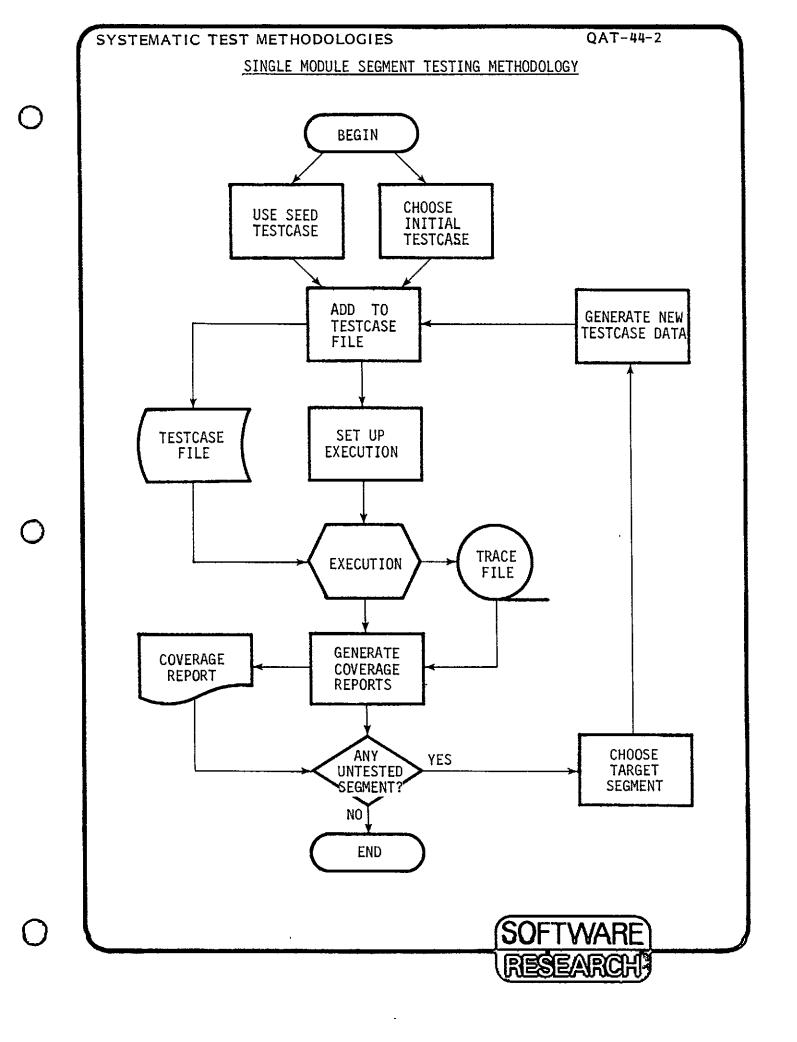
INTERFACE TESTING

- Demonstration of quality of interaction between subsystems
- * Protection of subsystems from each other

SYSTEM TESTING

- Formal acceptance testing and/or certification of software system
- Overall demonstration of function
- Assessment of service-ability, future "reliability," other measures or robustness





STRUCTURE BASED COVERAGE MEASURES -- MODULE LEVEL

Module Level Coverage Measures

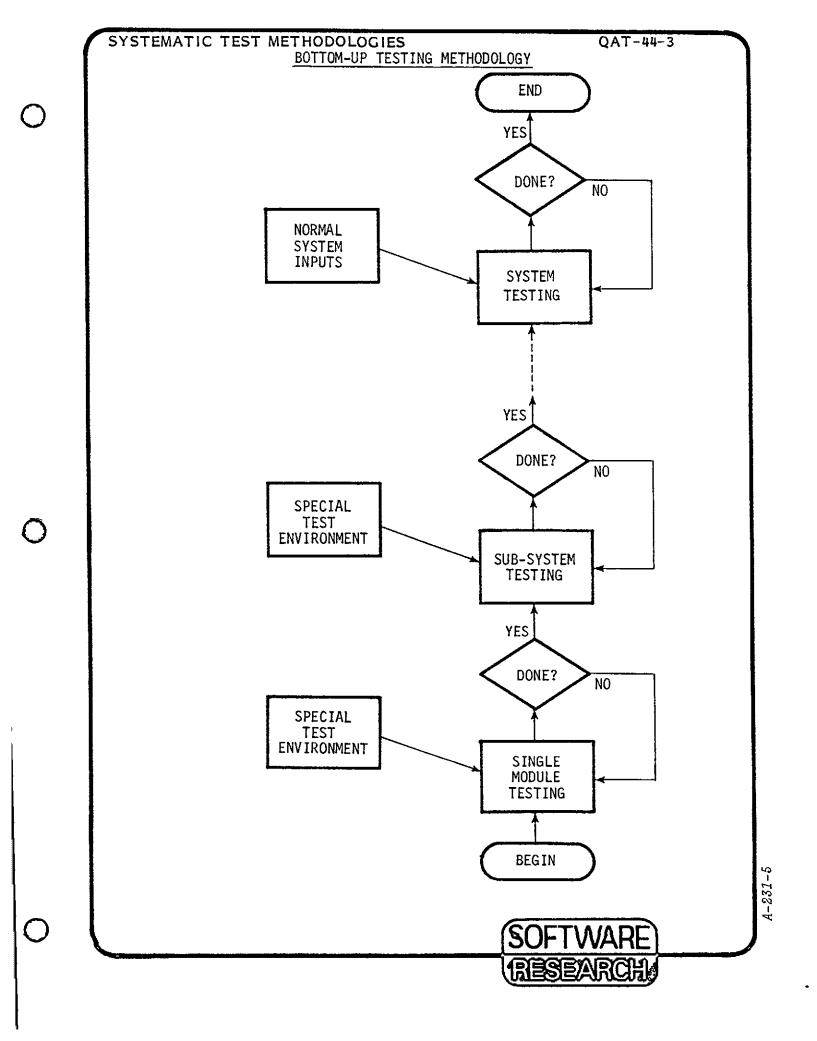
Name	Short Description	Comments
ω	Execute all statements in a a program.	Historically this is what most programmers "think" is the right level of testing, but it may leave out many segments.
C1-	Execute all non-null segments in each program.	This measure is close to the full C1 measure (below) and may in some cases be equivalent to it.
CI	Execute all segments in each program.	This is the basic measure of testing coverage now advocated by most experts. It has the intuitive benefit of attempting to exercise each "part" of a program.
CI+	Cl and also all interior and exterior features of iterations.	This measure extends C1 to include some of the basic properties of program iterations or loops in a way similar to that in proof of correctness.
Clp	Cl and each relational term to each possible outcome.	This measure extends Cl by requiring that each relational expression in any logical expression be exercised to each possible outcome. That is, predicates must be broken into their simple parts and each part tested.
C2	Cl and also one exterior and an upper and lower interior test.	This measure extends C1+ so that three properties of each iteration are checked: no iteration, a lower iteration count, and an upper iteration count. Each must be achieved on successive encounters of the loop.
C3	C2 plus each diff- erent non-iterative paths.	This extends C2 to include all of the non-iterative paths within the program structure. This may be difficult to achieve in practice.
Cik	C1 plus one test for each iteratiion i = 1, 2,,k times.	This measure requires that each cycle in the program be executed a fixed number of times, $i = 1, 2, 3,, k$, where k is normally set to an upper bound of $k = 2$.

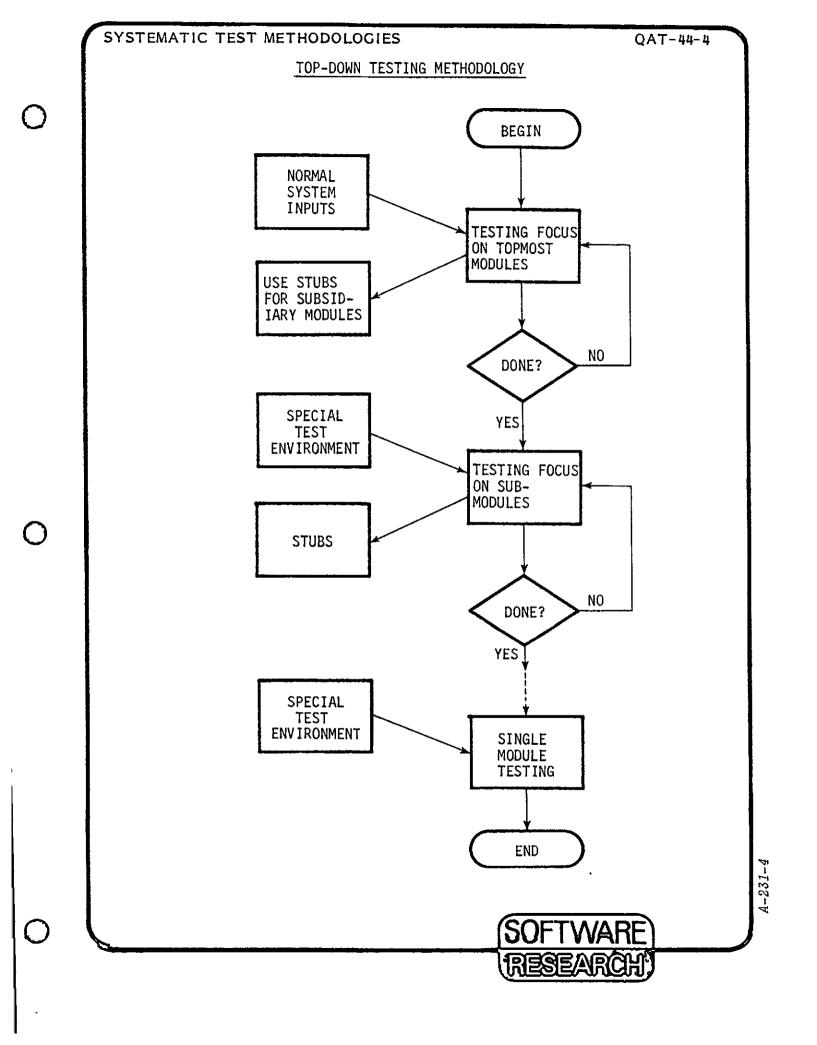


STRUCTURE BASED COVERAGE MEASURES -- SYSTEM LEVEL

Name	Short Description	Comments
S 0	Invoke all modules at least once.	This measure is insufficient to assure full exercise of a software system structure.
S1	All invocations to modules exercised at least once.	This is the minimum useful system level structural exercise measure.
25	All invocations to a module for each possible value of logical expression (actual) parameters.	This measure extends SI to account for the case when the actual parameter list has a logical expression, and requires that each possible outcome be exercised (similar to CI).
S2p	All invocations to a module for each possible logical outcome.	This measure extends S1 to include the case when the module has alternate logical outcomes, such as RETURN i or error modes (language dependent).
Sd	Every module down to a prespecified decisional depth.	This measure tries to require tests that execute the "most complex" parts of a software system, as measured by the decisional depth of the most deeply constrained segment.
St	All calling chains from the top module to any other module.	This measure requires that each distinct calling chain from the topmost module to every other module in the software system.
23	One invocation for all major equivalence classes possible.	This measure tries to capture "one test for each different equivalence class of invocation input," a kind of inter-modular data-exercise measure.







TCAT/C -- EXAMPLE COVERAGE ANALYSIS

ANALYSIS OF A SMALL "C" IMPLEMENTED SOFTWARE SYSTEM

STATISTICS ON "C" SYSTEM TESTED:

15 "C" MODULES

241 SEGMENTS

AVERAGE OF 16.07 SEGMENTS/MODULE

APPROXIMATELY 1500 LINES OF "C" CODE

STATISTICS ON THE SET OF TESTS:

32 SEPARATE TESTS

TEST EFFICIENCY: 7.53 SEGMENTS/TEST

LEAST COVERAGE OBTAINED IN ONE TEST: MOST COVERAGE OBTAINED IN ONE TEST:

AVERAGE COVERAGE PER TEST: 50%

INITIAL C1 VALUE: FINAL C1 VALUE:

1 TIME (1 MODULE) 906 TIMES (2 MODULES) LEAST INVOKED MODULES: MOST INVOKED MODULES:

"UPDATE" WITH 76.47% (3 INVOCATIONS) LEAST TESTED MODULE:

"GENDATA" WITH 100.00% (167 INVOCATIONS. MOST TESTED MODULE:

38 segments, 6346 segment hits)



QAT-50-2

RESULTS AFTER TEST NO. 1

TCAT Coverage Analyzer. COVER Version 1.8 (80 Column) (c) Copyright 1984 by Software Research Associates

T		THI	s Test		I CUMULATIVE SUMMARY I			
I Module I Name:	Number Of Segments:	No. Of Invokes	No. Of Segmen Hit		No. Of Invokes	No. Or Segmen Hit	ITS C1% COVER	
MAIN I MY_FOPEN BUILDTBL READCOM ENTERDATA GENDATA LOOKUP PRINTNUM RANGE ITOA I REVERSE GENRAND TOUCHFILE UPDATE FILECOPY	48 5551 3591 27355 173	1 7 1 1 1 1 0 0 0 0 0	1521451460000000000000000000000000000000000	31.25 40.00 40.00 580.46 45.00 45.00 60.00 10.00 10.00 10.00 10.00	1 2 1 7 1 1 1 1 0 0 0 0 0 0	15 31 45 21 46 00 00 00 00	31.25 40.36 45.00 45.00 45.00 45.00 60.00 60.00 10.00 10.00	
I Totals	241 I	109	88	36.51 I	109	88	36.51 <u>İ</u>	

CURRENT TEST MESSAGE (SAVED IN ARCHIVE):



QAT-50-3

RESULTS AFTER TEST NO. 10

TCAT Coverage Analyzer, COVER Version 1.8 (80 Column) (c) Copyright 1984 by Software Research Associates

I +		Тні	s Test]	I CUMULATIVE SUMMARY I			
I Module I Name:	Number Of 1 Segments:	No. Of Invokes	No. OF Segmen HIT	TS C1%	No. Of Invokes	No. Or Segmen Hit		
I MAIN I MY_FOPEN BUILDTBL I READCOM I ENTERDATA GENDATA LOOKUP PRINTNUM RANGE I TOA REVERSE GENRAND TOUCHFILE UPDATE FILECOPY	48 55 138 59 25 73 55 17 3	1 2 7 0 0 0 0 0 0	320550000000000000000000000000000000000	6.25 40.50 100.45 100.45 100.00 100.00 100.00 100.00 100.00	10 17 15 15 15 15 11 10 10 00 00	1948593587530000	39,58 80,00 100,27 100,82 100,84 100,89 100,00 100,00 100,00 100,00	
I Totals	241 I	76	45	18,67 1	993	156	64.73	

CURRENT TEST MESSAGE (SAVED IN ARCHIVE):



QAT-50-4

RESULTS AFTER TEST NO. 20

TCAT Coverage Analyzer, COVER Version 1.8 (80 Column) (c) Copyright 1984 by Software Research Associates

I		Тнг	s Test		CUMULATIVE SUMMARY I				
I Module I Name:	Number Of Segments:	No. Of Invokes	No. OF SEGMEN HIT	TS C1%	No. Of Invokes	No. Oi Segmei Hit			
I MAIN I MY_FOPEN I BUILDTBL I READCOM I ENTERDATA I GENDATA I LOOKUP I PRINTNUM I RANGE I ITOA I REVERSE I GENRAND I TOUCHFILE I UPDATE I FILECOPY	48 55 11 38 59 25 73 55 17 1	1 2 1 6 0 7 7 6 2 4 4 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	1521491569730000	31.25 40.00 74.55 80.82 81.26 100.00 100.00 100.00 100.00 100.00	20 319 529 68 80 515 50 00 00	20 52 59 37 58 37 30000	41.67 I 80.00 I 94.55 I 100.00 I 97.37 I 100.00 I 100.00 I 100.00 I 0.00 I 0.00 I		
I TOTALS	241 I	200	132	54.77 I	2038	173	71.78 I		

CURRENT TEST MESSAGE (SAVED IN ARCHIVE):



0AT-50-5

RESULTS AFTER TEST NO. 32

TCAT Coverage Analyzer, COVER Version 1.8 (80 Column) (c) Copyright 1984 by Software Research Associates

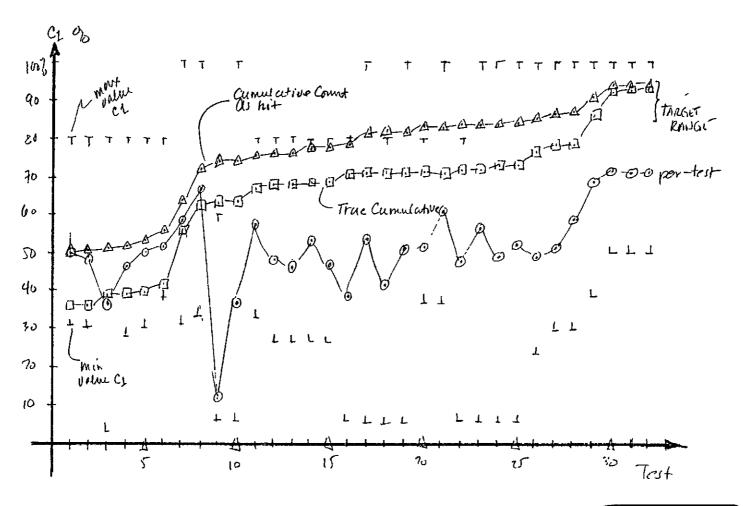
I +	I	Тні	s Test]	I CUMULATIVE SUMMARY			
I Module I Name:	Number Of I Segments: I	No. Of Invokes	No. Or Segmen HIT	TS C1% COVER	No. Of Invokes	No. On Segmen Hit	F NTS C1% Cover	
MAIN I MY_FOPEN I BUILDTBL I READCOM I ENTERDATA I GENDATA I LOOKUP I PRINTNUM RANGE I TOA I REVERSE GENRAND TOUCHFILE UPDATE I FILECOPY	48 I 55 I 1385 95 I 2735 I 173 I	31 11 9 11 11 10 1	24 47 49 84 87 15 30 13 13	50.00 I 80.00 I 80.45 I 80.82 I 73.68 I 88.00 I 88.00 I 88.00 I 100.00 I 76.00 I 76.00 I	32 73 73 8967 1507 8967 14286 992 133	453598595735433	89.58 I 100.00 I 96.36 I 100.00 I 100.00 I 100.00 I 100.00 I 100.00 I 100.00 I 100.00 I 100.00 I 100.00 I	
I TOTALS	241 I	97	169	70.12 I	3447	227	94.19 [

CURRENT TEST MESSAGE (SAVED IN ARCHIVE):

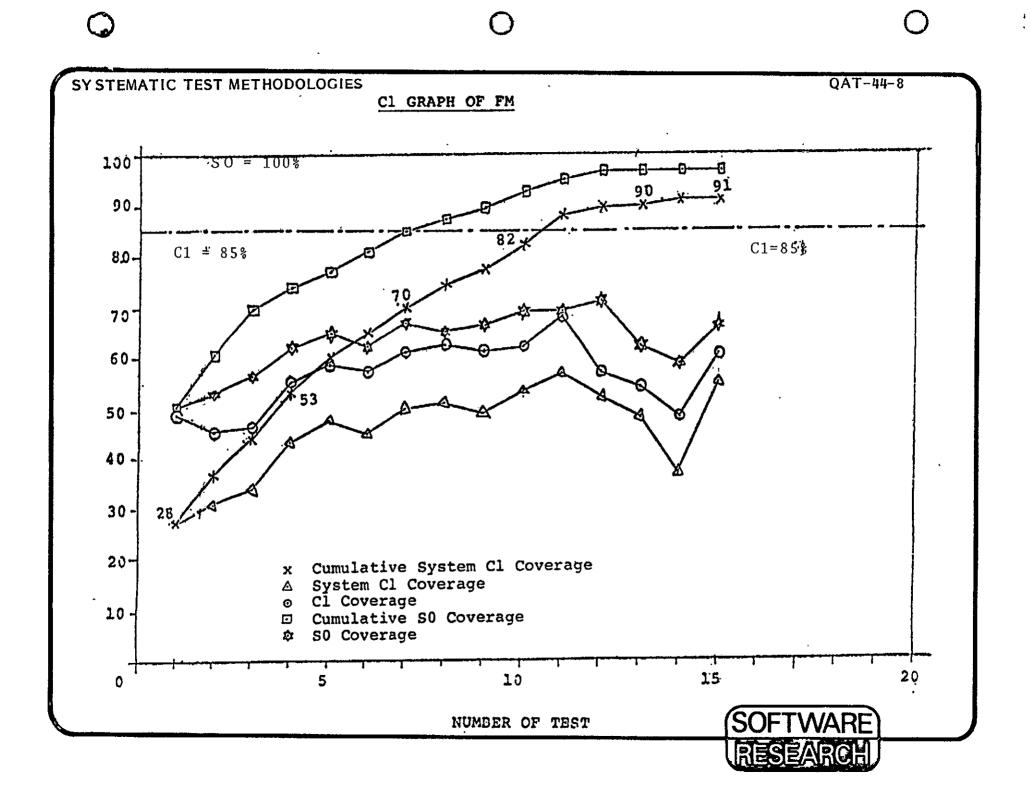


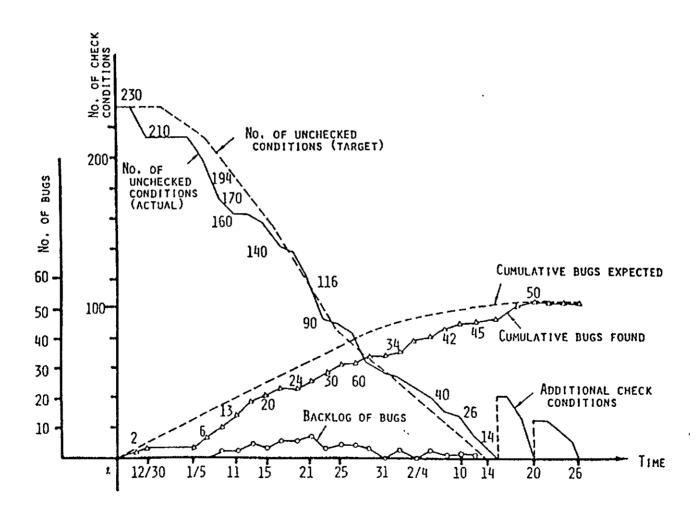
QAT-50-6

GRAPH OF OVERALL RESULTS









Source: Reifer, 5th Annual Pacific Northwest Software Quality, '87 SOFTWARE

C1 ANALYSIS OF SMALL COBOL PROGRAM

BACKGROUND FACTS

- * 2391 lines of text
- * 767 sentences
- * 371 segments
- Initial coverage achieved: 63% C1
- * Final coverage achieved: 87.1% C1

QA METHODOLOGY USED

- * Search for tests for untested segments.
- * Identify defects after each test.
- * Rerun tests upon correction of defect.
- Minimal formal recordkeeping.

PRIOR HISTORY OF COBOL PROGRAM

- * Less than six months operational use
- * Some defects found in operational use
- * Need for higher quality

• RESULTS

- * Defect discovery rate:
 - 1.3% of lines of text
 - 3.91% of sentences
- * Total defects found: 30
- Untested segments: 6
- * Cost estimate: %40-60/defect



TYPICAL ACTIVITY BASED ON HIGH COVERAGE USING JAVS

PILOT PROJECT:

To apply existing (prototype) tools and related Quality Assurance methodology to practical problem.

BACKGROUND

Central Flow Control (CFC) Software for FAA written in JOVIAL/J2 Dialect

- Approximately 23,700 statements processed.
- 98+% C1 coverage attained.
- Three stages of software evaluation: Unit testing level, subsystem testing level, and system/acceptance testing level.

RESULTS

- 3.57% NCSS unit testing errors
- 0.26% NCSS subsystem testing errors
- 0.08% NCSS system testing errors
- * 3.91% NCSS overall deficiency discovery rate

REFERENCE: P. C. Belford, R. A. Berg, and T. L. Hannan, "Central Flow Control Software Development: A Case Study of the Effectiveness of Software Engineering Techniques," *Proc.* 1979 Int'l. Conference on Software Engineering, September 1979.



DYNAMIC TESTING — C1 BASED APPROACH

GOAL: Thorough Exercise of Program(s)

NOTE: C1 is defined as the percentage of logical segments in a program that are exercised by any one test. The *normal* goal is to achieve an aggregate value of 100% C1 over a series of tests. 85% C1 is sometimes acceptable in practice for various technical reasons.

MECHANISM: Integrated, Automated Testbed (Test Harness) to Support Major Bookkeeping Functions Needed by Software Test Engineer

NOTE: Typical systems have been built to include the functions listed below:

- Automatic C1 coverage analysis
- * Assistance in setting input values and evaluating output values
- Centralized statistics gathering for multiple tests
- * Some form of results comparison (automated)

SOME GUIDELINE FACTS

- * Number of Segments is approximately 25% of KLOC.
- No more than one test per Segment is normally required, with typically 2 - 8 Segments "retired" per test.
- * 85% C1 level is relatively easy to achieve, 100% C1 may require some "exceptions".
- Most "off-the-assembly-line" programs achieve between 25 50%
 C1 coverage.

REFERENCE: E. F. Miller and W. E. Howden, "Software Testing and Validation Methods," IEEE Computer Society, September 1978.



SUMMARY OF OPERATION OF TESTING FACTORY

Quantity	Total/Average
Modules	128
Statements	60881
Segments	4378
Test Cases Used	1544
Coverage Attained	89.7%
Code Violations	1296
Program Errors	190
Total Discrepancy Reports	1486
Statements/Error	40.96
Error Rate (/Statement)	2.44%



S-TCAT/C -- EXAMPLE COVERAGE ANALYSIS

SYSTEM AND INTERFACE ANALYSIS OF A "C" SOFTWARE SYSTEM METRIC USED: SI (% OF POSSIBLE CALL-PAIRS EXERCISED) STATISTICS ON "C" SYSTEM TESTED:

15 "C" MODULES

65 CALL-PAIPS

AVERAGE OF 4.33 CALL-PAIRS/MODULE APPROXIMATELY 1500 LINES OF "C" CODE

STATISTICS ON THE SET OF TESTS:

36 SEPAPATE TESTS

TEST EFFICIENCY: 1.81 CALL-PAIRS/TEST

LEAST SI COVEPAGE OBTAINED IN ONE TEST: 6.00% MOST SI COVERAGE OBTAINED IN ONE TEST: 67.69%

INITIAL SI VALUE: 41.67% FINAL SI VALUE: 86.15%

LEAST INVOKED MODULES: 1 TIME (2 MODULES) MOST INVOKED MODULES: 1128 TIMES (2 MODULES)

AVERAGE NUMBER OF INVOKES/TEST: 267.8



```
S-TCAT ANALYSIS OF TESTS
                                                                                  QAT-53-8
List of blocked function names. When a name arrears in this file
S-TCAT/C does NOT instrument for this name.
short
abs
assent
lots
         atoi
                 atol
                                                   toascii
tourper tolower _tourper
                                  _tolower
         localtime
                         amtime asctime
ctime
isəlphə isupper islower isdidit isxdidit
                                                  isalnum isspace
         isrunct isrrint isgraph isontal isascii
cuserid
ecut fout sout
exit
EXP
         los
                 FOWE
                          sart.
fclose fflush
feof
         ferror clearerr
                                  fileno
         ceil
                 fmad
floor
                         fabs
         freoren fdoren
foren
         furite
 fread
frexe
         1 dexp
                 merelf
fseek
         ftell
                 rewind
         setchar fsetc
 setc
                          setw
deteny.
                                                   endsrent
 setsment
                 setsrnam
                                  setarent
 detlodin
 setoet.
                 setrwuid
                                  setrunam
                                                   setrwent
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 setrwent
 dets
         fdets
 13tol
         1to13
 Logname
 malloc realloc calloc
mktemp
 monitor
 nlist
 Perhor
 er i ritf
         ferintf serintf
         frutc
                 Futw
 Putc
```

S-TCAT ANALYSIS OF TESTS

QAT-53-2

RESULTS AFTER TEST NO. 1

S-TCAT Coverage Analyzer. SCOVER Version 1.85 (80 Column) (c) Copyright 1985 by Software Research Associates

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Current test message (saved in archive):

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QAT-53-6

RESULTS AFTER TEST NO. 36

S-TCAT Coverage Analyzer. SCOVER Version 1.85 (80 Column) (c) Copyright 1985 by Software Research Associates

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I	readcom	0	I	2	O	100.00	Ţ	93	0	100.00	
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Ι	rande	0	r	1.	O	100.00	I	34	0	100.00	I
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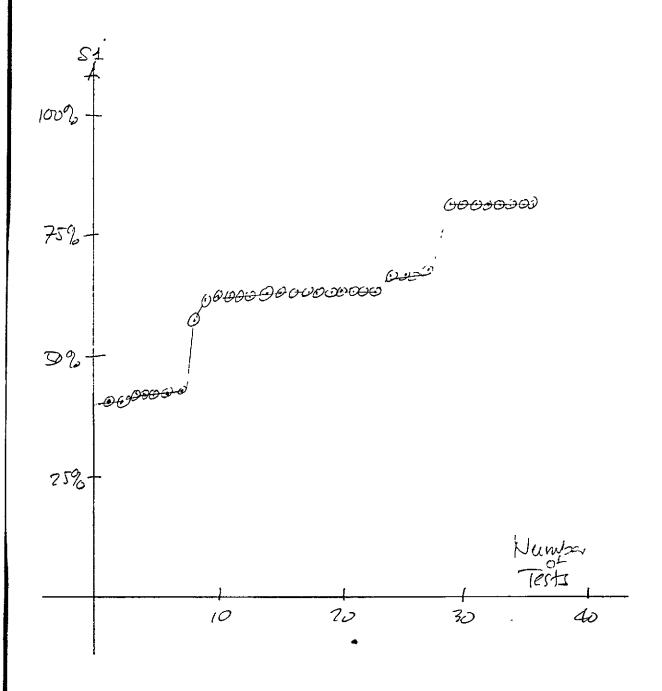
Current test message (saved in archive):



S-TCAT ANALYSIS OF TESTS

QAT-53-7

GRAPH OF OVERALL SI COVERAGE RESULTS





EXAMPLE COMPUTATION

ORIGINAL SITUATION

32 TESTS FOR 15 MODULES OF "C"

TOTAL LENGTH APPROXIMATELY 1500 LINES

CUMULATIVE C1 = 91.57% FROM 32 TESTS

AUTOMATED TEST RE-PUN CAPABILITY EXISTS

INDIVIDUAL TEST COVERAGE RANGE:

Low: C1 = 2.39%

HIGH: C1 = 69.08%

TEST SELECTION METHOD

CHOOSE HIGHEST C1 TEST FIRST

COMPUTE ALL 2ND TEST C1 CONTRIBUTION

CHOOSE HIGHEST-CONTRIBUTION 2ND TEST

REPEAT FOR 3RD TEST, 4TH TEST, ETC.

IN CASE OF MULTIPLE CHOICES CHOOSE FIRST OCCURING INSTANCE (ARBITRARY ORDER)

CONTINUE UNTIL MAXIMUM COVERAGE IS ACHIEVED



DERIVED EFFICIENT TEST ORDER

OLD	New
ORDER	Order
12345678911123456789012	TEST-29 TEST-27 TEST-63 TEST-63 TEST-12 TEST-12 TEST-12 TEST-14 TEST-16 TEST-16 TEST-16 TEST-16 TEST-17 TEST-1



TCAT Coverage Analyzer. COVER Version 1.8 (80 Column) (c) Copyright 1984 by Software Research Associates

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I	buildtbl	55	I	1	47	85.45	1	1	47	85.45	I
1	readcom	5	I	2	4	80.00	I	2	4	80.00	I
I	enterdata	11	I	31	9	81.82	I	31	9	81.82	I
I	sendata	42	1	11	30	71.43	I	11	30	71.43	I
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I	Totals	249	I	96	172	69.08	I	96	172	69.08	I

Current test message (saved in archive):

RuntimeVersion1.2. Last undated on 6-12-84



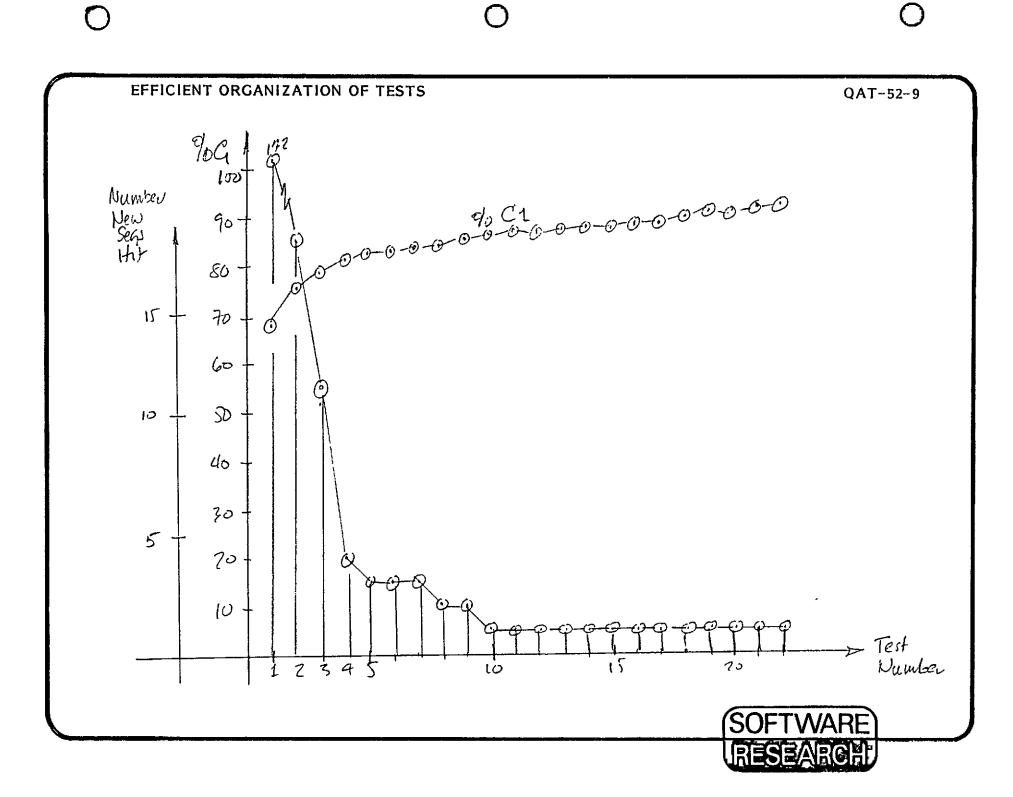
TCAT Coverage Analyzer. COVER Version 1.8 (80 Column) (c) Copyright 1984 by Software Research Associates

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I	my_foren	5	I	1	2	40.00	1	44	4	80.00	I	
I	buildtbl	55	I	1	37	67.27	I	21	53	96.36	I	
I	readcom	5	1	5	4	80.00	I	61	5	100.00	I	
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I	lookur	5	I	0	O	0.00	I	70	5	100.00	I	
I	Frintnum	9	1	0	O	0.00	I	68	9	100.00	I	
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I	filecopy	3	I	0	0	0.00	I	2	3	100.00	I	
I	Totals	249	Ι	164	83	33.33	I	2271	228	91.57	I	

Current test message (saved in archive):

RuntimeVersion1.2. Last undated on 6-12-84





COVERAGE CURVE OF REORDERED TESTS

Total of 249 segments

•		I Individual Tests			I I Cumulative Results		
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Ĭ I +.	2 <u>1</u> 22	87 164	1 <u>42</u> 83	57.03 I 33.33 I	2107 2271	227 228	91:16 I 91:57 I



GENERIC SYSTEM-LEVEL TESTING PLANS

Very often certain kinds of system characteristics can form the basis of a systematic approach to system test planning.

These categories represent some extremes that may be encountered.

VERTICAL SYSTEM

- Deep Interconnection Diagram
- * Strong Bottom-Up Dependence
- → Use Bottom-Up Testing

HORIZONTAL SYSTEM

- * Flat Interconnection Structure
- * Primary Top-Down Dependence
- * Use Top-Down Testing

• PARTIALLY IMPLEMENTED SYSTEMS

- Bottom-Up Implementation
- * Top-Down Implementation
- Mixed Implementation



APPLIED SOFTWARE TESTING -- CASE STUDY DESCRIPTIONS

CASE STUDY FOCUS:

TYPICAL SITUATIONS

BEST INDUSTRIAL-STPENGTH METHODOLOGY

AUTOMATION OF FUNCTION

HIGH QUALITY

PPODUCTIVITY GAINS THROUGH:

INCREASED RATE OF PRODUCTION

LOWER COSTS TO DETECTS

BETTER AND LOWEP-COST FIITURE TESTING

CLASSES OF CASE STUDIES

TEST SUITE DEVELOPMENT

COMPREHENSIVE PRODUCT TESTING

DETAILED TECHNICAL TESTING

VALIDATION TESTING



CASE STUDY ORGANIZATION

TEST SUITE DEVELOPMENT

INTEPPRET FUNCTIONAL SPECIFICATIONS
ACCOUNT FOR PASS/FAIL RATIOS
AUTOMATIC APPLICATION

COMPREHENSIVE PRODUCT TESTING

DESIGN FUNCTIONAL TESTS
CHECK TEST MATPIX
BUILD & APPLY TESTS
REPORT DEFECTS

DETAILED TECHNICAL TESTING

EXPLOIT PROPERTIES OF PRODUCT

DEFECT-PPONE MODULE IDENTIFICATION

VALIDATION TESTING

INSPECTION

FUNCTIONAL TESTING

CONVERGENCE TESTING

PEGRESSION TESTING



APPLIED SOFTWARE TESTING

SR-91-A1

CASE STUDY A -- DEVELOP PROGRAMMING ENVIRONMENT TEST SUITE (REF #0890)

SITUATION:

NEW PROGRAMMING ENVIPONMENT

FORMAL SPECIFICATION EXISTS

REQUIREMENT:

FULL-VALIDATION STYLE TEST SUITE

LIMITED SUBSET OF FUNCTIONS

KERNEL FUNCTIONS NEED MAIN ATTENTION

CONTEXT:

NON-STANDARD HARDWARE

NON-STANDARD LANGUAGE

INTERNATIONAL CLIENT



METHODOLOGY USED

TEST PLANNING:

FUNCTIONAL SPECIFICATION ANALYSIS 100% AUTOMATED TEST CONTROL PROGRAM

TEST PROPERTIES:

SELF-CHECKING TEST FORMAT

MANUAL VALIDATION TO SPECIFICATION

SPECIAL FEATURES:

STANDARD PASS/FAIL PEPORTING STANDARD ACCOUNTING



RESULTS ACHIEVED

PRODUCT:

157 TEST PROGRAMS

471 TESTS

175 COMMANDS, CALLS, DRIVES, FUNCTIONS TESTED

AUTOMATED TEST FXECUTOR

AUTOMATED RESULTS REPORTING

APPLICATION:

APPROX. 24 DEFECTS DETECTED

APPROX. 40 HRS TEST EXECUTION TIME

TESTS REQUIRE MANUAL VALIDATION

8 HRS FOR RE-EXECUTION

COST/DEFECT: \$1K (ASSUMES NO VALUE FOR SYSTEM)

RE-APPLICATION

MAJOR SYSTEM IMPROVEMENTS OBSERVED ONLY MINOR NEW DEFECTS FOUND



CASE STUDY B -- DEVELOP PL/I TEST SUITE (REF #1010)

SITUATION:

NEW PL/I COMPILER
MULTIPLE HARDWARE SYSTEMS

REQUIREMENT:

PPE-RELEASE TESTING NEEDED
FULL-VALIDATION NOT NEEDED

CONTEXT:

ADVANCED FUNCTION PRODUCT
PRIOR DEFECT-PRONE HISTORY
SHORT SCHEDULE
US CLIENT



METHODOLOGY USED

TEST PLANNING:

CAREFUL STUDY OF LANGUAGE SPEC APPLY "TOUCH TEST" PRINCIPLE

TEST PROPERTIES:

TEST MATRIX DEVELOPED SMARTS CONTROL

SPECIAL FEATURES:

DEVELOPMENT VERSION OF COMPILER ONLY ERROR-PRONE ENVIRONMENT



sp-91-B3

RESULTS ACHIEVED

PRODUCT:

165 TEST PROGRAMS

2 AUXILIARY FILES

28 TEST SCRIPTS

11.167 LINES OF PL/I CODE

164 BASELINE FILES

APPLICATION:

31 DEFECTS DETECTED

6-8 HRS TEST EXECUTION TIME

COST/DEFECT: \$.5K (ASSUMES NO VALUE FOR PRODUCT)

SUBSEQUENT HISTORY:

BASIS FOR COMMERCIAL PL/I PRODUCT



CASE STUDY C -- TEST ASSEMBLER PRODUCT (REF #0954)

SITUATION:

MAJOR PRODUCT (COMPLETE MACRO ASSEMBLER)

VERY-GREAT TECHNICAL SOPHISTICATION

MACRO PROCESSOR

MANY USER OPTIONS

SOME INTERNAL TESTING COMPLETED

REQUIREMENT:

100% FUNCTIONAL COVERAGE IN TESTS

AUTOMATIC OPERATION

CONTINUAL DEFECT REPORTING

CONTEXT:

PC/DOS ENVIRONMENT

STANDARD CPU PART

DOMESTIC CLIENT



METHODOLOGY USED

TEST PLANNING:

BASED ON TECHNICAL MANUAL COMPREHENSIVE TEST MATRIX

TEST PROPERTIES:

"FLAT" TEST ORGANIZATION
SIMPLE TESTS

MANY OF THEM

MAXIMUM INDEPENDENCE OF TESTS

MECHANIZED CONTROL:

SMARTS BASED REGRESSION

MULTIPLE PC DEVELOPMENT

AUTOMATED COMPARISON REQUIRED

SPECIAL FEATURES:

MANUAL REVIEW COMPLETED

SPECIAL PEGRESSION TECHNIQUES USED

FULL TURNOVER OF TESTS TO CLIENT

FULL TURNOVER OF BASELINE OUTPUTS TO CLIENT



RESULTS ACHIEVED

PRODUCT:

5.400 LINES OF SMARTS CONTROL FILE

APPLICATION:

160 DEFECTS FOUND

3-5 DAYS TEST EXECUTION TIME

COST/DEFECT: \$.6K (ASSUMES NO VALUE FOR TEST SUITE AND REGRESSION SYSTEM)

RE-APPLICATION:

MAJOR QUALITY IMPROVEMENT

COMMERCIAL PRODUCT RELEASED



CASE STUDY D -- TEST HI-END PUBLISHING PRODUCT (REF #0988) SITUATION:

HI-END PUBLISHING PRODUCT

SUN WORKSTATION

WINDOWS

MOUSE

KEYBOARD

OBJECT-OPIENTED PROGRAMMING

PEQUIREMENT:

AUTOMATIC PEGRESSION TOOL

INITIAL TEST DESIGN

INITIAL TEST DEVELOPMENT

CREATION OF TEST BASELINE

CONTEXT:

DOMESTIC CLIENT

HI-PEPFORMANCE ARCHITECTURE

EXTREMELY SOPHISTICATED PRODUCT



METHODOLOGY USED -- TEST SUPPORT TOOL

TEST TOOL PLANNING:

CAPBAK DESIGN BASE

DESIGN OF INPUT CAPTURE

KEYBOARD

MOUSE

SUBSCREENS

DESIGN OF REPLAY

AUTOMATED COMPARISON

TOOL PROPERTIES:

HIGHLY INTERACTIVE SYSTEM

SMARTS INTEGRATION

SPECIAL FEATURES:

SCREENSAVE OF SUBWINDOWS

AUTOMATED COMPARISON OF WINDOWS



APPLIED SOFTWARE TESTING

METHODOLOGY USED -- TEST DEVELOPMENT

TEST PLANNING:

BASED ON EXISTING MANUAL TESTS
REORGANIZED FOR MECHANIZED OPERATION

TEST PROPERTIES:

210 TESTS BUILT

650-950 SUBTESTS CONSIDERED

DEPENDS ON DEFINITION OF SUR-TEST

TYPICALLY, "SUB-TEST" = SUB-WINDOW

SPECIAL FEATURES:

FEEDBACK INTO DEFFCT TPACKING
CONNECTION TO TRAINING DEPARTMENT



APPLIED SOFTWARE TESTING

se-91-D4

RESULTS ACHIEVED

PRODUCT:

TEST SYSTEM DOES 100% AUTOMATIC TEST REGRESSION

APPLICATION:

22 DEFECTS DETECTED

3-4 DAYS TEST EXECUTION TIME

MANUAL ASSISTANCE AND VALIDATION

SYSTEM IS INTERACTIVE

COST/DEFECT: \$2.2K (ASSUMES NO VALUE ON TEST SUITE

OR REGRESSION SYSTEM)



CASE STUDY E -- TEST UNIX OPERATING SYSTEM (REF #0877)

SITUATION:

NEW HAPDWAPE RELFASE

PROPRIETARY CPU

SOFTWARE PORT PLUS SPECIAL FEATURES

REQUIREMENT:

VALIDATION OF KERNEL

FUNCTIONALITY

PERFORMANCE

VALIDATION OF SYSTEM PROPERTIES

IDENTIFICATION OF USER PROBLEMS

CONTEXT:

DOMESTIC CLIENT

HI-TECHNOLOGY HARDWAPE



APPLIED SOFTWARE TESTING

sR-91-E2

METHODOLOGY USED

TEST PLANNING:

USER DOCUMENTATION AS TEST PLAN BASE

SPECIAL COMPATIBILITY TESTS

ANOTHER XENIX AS BASE

MANUAL VALIDATIONS

TEST PROPERTIES:

66 TESTS (182 SUBTESTS) OF KERNEL INTERFACE (USVS)

87 TESTS (150 SUBTESTS) OF LIBRARY FUNCTIONS (USVL)

141 TESTS (TESTING 665 SWITCHES OF 195 COMMANDS)

OF UTILITY FUNCTIONS (USVU)

SPECIAL FEATURES:

PART OF 'STANDARD TEST SUITES' FOR UNIX COMMERCIAL OFFERING



APPLIED SOFTWARE TESTING

sr-91-E3

RESULTS ACHIEVED

PRODUCT:

ALL TESTS RUN

2 CONFIGURATIONS

APPLICATION:

31 DEFECTS

COST/DEFECT: \$1K (ASSUMES NO VALUE FOR SUITE)



CASE STUDY F -- TEST XENIX OPERATING SYSTEM (REF #0795B)

SITUATION:

NEW SOFTWARE RELEASE IN EARLY STAGES

OF DEVELOPMENT

VARIOUS HARDWARE CONFIGURATIONS

REQUIREMENT:

FUNCTIONALITY VERIFICATION

TESTING OF DRIVERS

MULTIPLE REGRESSIONS (ON 5 RELEASES)

CONTEXT:

DOMESTIC CLIENT

MID-TECHNOLOGY HARDWARE



METHODOLOGY USED

TEST PLANNING:

REUSE OF EXISTING TEST SUITES
SOME NEW TESTS NEEDED

TEST PROPERTIES:

- 107 TOUCH TESTS OF 177 BASE COMMANDS WITH 449 SWITCHES
- 51 TOUCH TESTS OF 56 SOFTWARE DEVELOPMENT SYSTEM
 COMMANDS WITH 288 SWITCHES
- 20 TOUCH TESTS OF 31 TEXT PROCESSING COMMANDS WITH 107 SWITCHES
- 1 FULL TEST OF SYSTEM INITIALIZATION CODE
- 53 FULL TESTS OF CRT
- 10 FULL TESTS OF KEYBOARD
- 100 FULL TESTS OF TTY
- 36 FULL TESTS OF FLOPPY DISK
- 20 FULL TESTS OF HARD DISK
- 126 FULL TESTS OF SERIAL PORTS
- 12 FULL (ADDITIONAL) TESTS OF MULTI-PORT BOARD
- 6 FULL TESTS OF PARALLEL PORTS
- 25 FULL TESTS OF CO-PROCESSOR
- 6 FULL TESTS OF TIMER
- 7 FULL TESTS OF CLOCK
- 17 FULL TESTS OF MMU



RESULTS ACHIEVED

PRODUCT:

TESTS RUN ULTIMATLEY ON 5 RELEASES

MANY MACHINE CONFIGURATIONS

DIFFERENT MACHINES

SINGLE-USER

MULTI-USER

LINKED TOGETHER

APPLICATION:

95 ERRORS AND 3 INCIDENTS REPORTED

40+ HRS TEST EXECUTION TIME

COST/DEFECT: \$1K (ASSUMES NO VALUE ON SUITE)



APPLIED SOFTWARE TESTING

sr-91-61

CASE STUDY G -- TEST PATIENT ORIENTED MEDICAL PRODUCT (REF #0813)

SITUATION:

MEDICAL PRODUCT, USED BY PATIENT

MEASURES BLOOD SUGAR

RECORDS INFORMATION OVER TIME

REPORTS TO CENTRAL COMPUTER

REQUIREMENT:

FUNCTIONAL TESTING
COVERAGE ANALYSIS
REGRESSION TESTS

CONTEXT:

DOMESTIC/INTERNATIONAL CLIENT
HIGH CRITICALITY (MEDICAL PRODUCT)



METHODOLOGY USED

TEST PLANNING:

TESTS BASED ON FUNCTIONAL SPECS
TESTS ORGANIZED THROUGH TEST MATRIX

TEST PROPERTIES:

39 TESTS DEVELOPED: FUNCTIONAL + STRESS

11 CONVERGENCE TESTS

2 SYSTEM CONVERGENCE TESTS

52 TOTAL

Cl = 87% ACHIEVED

SPECIAL FEATURES:

CAPBAK USED TO RECORD ALL TESTS

MANUAL INITIATION OF REPLAY WITH CAPBAK

SOFTWARE INCIDENT REPORT SYSTEM INSTITUTED



RESULTS_ACHIEVED

PRODUCT:

TESTS BUILT, APPLIED

TESTS PRESERVED ON KEYSAVE FILES FOR

REGRESSIONS AND FOR FUTURE (FDA?) ENQUIRIES

CODE AND TESTS UNDER CONFIGURATION CONTROL

INTERMEDIATE COVERAGE REPORT FILES CONSERVED FOR

FUTURE ENQUIRIES

APPLICATION:

12 DEFECTS DETECTED

40+ HRS TEST EXECUTION TIME

COST/DEFECT: \$2K (ASSUMES NO COST FOR TEST SUITE,

KEYSAVE FILES, CONFIGURATION SYSTEM)

REGRESSION ON NEW VERSION:

2 DEFECTS NOTED
40+ HRS TEST EXECUTION TIME



CASE STUDY H -- TEST A MEDICAL PRODUCT (REF #1020)

SITUATION:

HARDWARE/SOFTWARE PRODUCT

USED FOR QUALITY ANALYSIS OF MEDICAL PRODUCT

PRODUCES ANALYTIC REPORTS

REQUIREMENT:

FULL VALIDATION TESTING

COVERAGE LEVELS SPECIFIED

VALIDATION SYSTEM REQUIRED

REGRESSION SYSTEM REQUIRED

CONTEXT:

HIGH CRITICALITY
MODERATE SIZE PRODUCT



METHODOLOGY USED

INSPECTION:

UNIT-LEVEL INSPECTION
SYSTEM-LEVEL INSPECTION

TEST PLANNING:

FUNCTIONAL TEST PLANNING

SPECIFICATIONS

IN PART FROM CODE

ALL TESTS UNDER SMARTS CONTROL

FUNCTIONAL TESTING:

INITIAL MANUAL TEST VALIDATION AUTOMATED DIFFERENCING

CONVERGENCE TESTING:

Cl > 95% REQUIRED

S1 > 99% REQUIRED

REGRESSION TESTING:

MULTIPLE REGRESSIONS

VALIDATION SYSTEM DEVELOPED



RESULTS ACHIEVED

PRODUCT:

23 FUNCTIONAL TESTS

15 FORMAT AND ERROR TESTS

13 OTHER FUNCTIONAL TESTS

14 COSMETIC TESTS

65 TOTAL

VALIDATION SYSTEM

65 VALIDATED BASELINE FILES

REGRESSION SYSTEM (SMARTS CONTROL FILE)

PRODUCT ITSELF REQUIRES MANUAL INTERVENTION

APPLICATION:

INSPECTION STAGE

71 MODULE ANOMALIES

65 SYSTEM ANOMALIES

52 ERs

DYNAMIC TESTING

11 FUNCTIONAL TESTING INCIDENTS

11 CONVERGENCE TESTING INCIDENTS

TOTAL: 74 DEFECTS DETECTED

TEST EXECUTION TIME

8-12 HRS WITHOUT PRINTING

36-48 HRS WITH PRINTING

COST/DEFECT: \$.5K (ASSUMES NO VALUE FOR TEST SUITE

REGRESSION SYSTEM, VALIDATION SYSTEM)



RELIABILITY ANALYSIS — DEFECT REMOVAL PROCESS

GOAL

Model the current series of defect removal steps, predict remaining defects based on historical experience.

DEFECT REMOVAL STEPS

- (1) Code Inspections/Reviews: Standard IBM-like processing during software production
- (2) System Testing: Pre-release examination by independent testing group
- (3) Field Testing: Users find defect during (attempted) normal use of software

MODEL USED

- Each step assumed to remove Pi fraction of total number of original defects.
- * Overall effectiveness is (1-P1)(1-P2)...(1-Pi).

APPROXIMATE VALUES

NOTE: P1, P2, and P3 are "Company Confidential" and highly dependent on the methodologies and personnel used. Good guess is Pi = 90% in all cases. This implies overall residual defect rate approximately 0.01% NCSS.

NOTE: Original defect rate is in 2.0 - 4.0% NCSS range, with 3.0% the "best guess" value.

UNANSWERED QUESTIONS

- Now many remaining defects?
- * How do users feel about assisting in the defect removal process?

REFERENCE: H. Remus and S. Zilles, "Prediction and Management of Program Quality," *Proc. 1979 Int'l. Conference on Software Engineering*, Munich, West Germany, September 1979.



RELIABILITY ANALYSIS — NEXT ERROR DISCOVERY PREDICTION

GOAL

Define an error statistic, develop model of error behavior, compute probability of an error in the future.

BASIC METHODS

- Extension of hardware reliability assessment (application dependent)
- Based on analysis of properties of software system itself (application dependent)

NOTE: Software dependent model discussed later.

HARDWARE RELIABILITY MODELS

- * Constant Error Rate: Does not match reality.
- * Jelinski-Moranda Model: Random error detection, error rate proportional to number of remaining faults.
- * Schick-Wolverton Model: Same as Jelinski-Moranda, except error rate proportional also to length of time testing (equally probable error discovery statistics in testing).
- * Shooman Model: Same as Jelinski-Moranda, but includes total debugging and total execution time.
- * Schneidewind Model: Errors assumed Poisson distributed, mean number of errors detected decreases exponentially with time (same level of testing competence), error rate proportional to remaining errors.
- * MUSA Model: Errors present and not found are function of total execution time of program (actual use time).

PROBLEMS

- Calibration Statistics (Model Validation)
- Inaccuracies in modeling software as "hardware"

REFERENCE: J. C. Rault, "Quantitative Measures for Software Reliability," *Infotech State of the Art Report*, 1979.

TESTING OF EXPERT SYSTEMS

PRINCIPLES OF EXPERT SYSTEMS

USER INPUT/OUTPUT INTERFACE

RULE SET

INFERENCE ENGINE

QUALITY ISSUE IN EXPERT SYSTEMS

POSITIVE FAILURES

INCORRECT RULE

INCORRECT DEDUCTION

COMBINATION

NEGATIVE FAILURE

OMITTED RULE

MISSING INTERMEDIATE LEMMA

OTHER DEFICIENCY SOURCES

DEFICIENCY IN INFERENCE ENGINE

HARDWARE DEFICIENCY

INSUFFICIENTLY CHECKED HUMAN INPUT

COMBINATION



EXPERT SYSTEM'S QUALITY ASSESSMENT

FAILURE MODES

USER INPUT ERRORS

INCONSISTENT INPUT FACTS

ERRORS IN RULESET

INCORRECT REDUCTION(S)

INCORRECT VALIDATIONS

IMPACT OF FAILURE

IMAGE

FIELD REPLACEMENT COST

DAMAGE COMPENSATION

LIABILITY

DEGREE OF DIFFICULTY

RULESET PROGRAMMING

SYSTEM INTEGRATION

COMPONENT FAILURE MODES

USER TRAINING



USER INPUT ERRORS

FAILURE MODE:

USER TYPES INCORRECTLY
USER "FORGETS" CONTEXT
SIMPLE PILOT ERROR

EXAMPLE:

WRONG PATIENT NAME
WRONG MACHINE SITE

ESTS_ REMEDY:

INPUT CHECKING REQUIRES "SANITY" MODEL
CREATE ARCHIVE OF FULL-SESSION TESTS
VALIDATE TESTS INDEPENDENTLY



INCONSISTENT FACTS

FAILURE MODE:

ATOMIC "FACTS" ARE NOT TRUE
"COMBINATIONS OF FACTS" ARE NOT TRUE

EXAMPLE:

ACTUAL FACTUAL DEFECT

INCORRECT FORMULA

INTERFACE ERROR

ESTS REMEDY:

AT LEAST ONE TEST MUST USE EACH FACT.

100% RULE COVERAGE (LR1)

AUTOMATED REGRESSION ON EXAMPLE SESSIONS



ERROR IN RULESET

FAILURE MODE:

MISSING, WRONG, EXTRA RULE
INCOMPLETE CONSISTENCY CHECKING
INCOMPLETE "EXPERT" UNDERSTANDING
FIRING ORDER DEPENDENCE
MISSING/INCORRECT DATA FLOW
ESTIMATE: 20 DEFECTS/KRULE

EXAMPLE:

THE "FLYING ZEBRA"

ESTS REMEDY:

POSSIBLE FORMAL MANUAL INSPECTION

FULL PATH ANALYSIS APPEARS NECESSARY (LRT)

LR1 MAY BE AN EFFECT APPROXIMATION TO LRT



INCORRECT REDUCTION

FAILURE MODE:

RULES ARE CORRECT: FAILURE IN REDUCTION CONVENTIONAL SW STATISTICS APPLY

EXAMPLE:

MISSED RULE IN BACKTRACKING

ESTS REMEDY:

USE COMMERCIAL STS METHODS
ANALOGOUS TO COMPILER VALIDATION



TESTING EXPERT SYSTEMS

INVALID OUTPUT

FAILURE MODE:

INSUFFICIENT CHECKING OF RESULTS

SYSTEMIC FAILURE

EXAMPLE:

MISSED DIAGNOSIS

INCORRECT CONFIGURATION

ESTS REMEDY:

STRUCTURIZATION OF RULESET

PARTITIONING OF TESTING WITHIN ESTS



COMMERCIAL SOFTWARE TEST SERVICES (STS)

TURNKEY SERVICE STRUCTURE

CODE INSPECTION

SYSTEM INSPECTION (INTERFACES)

TEST PLANNING & FUNCTIONAL TESTS

Cl COMPLETION

SI COMPLETION

REGRESSION

COSTS

LOW RANGE

₹ 20 KLOC

NORMAL QUALITY CODE

\$10K-\$25K/KLOC

30-40 REPORTS/KLOC

HIGH RANGE

> 40 KLOC

NORMAL TO LOW QUALITY CODE

\$15K-\$35K/KLOC

20-30 REPORTS/KLOC



EXPERT SYSTEMS QUALITY CONTROL

QAT-92-3

TEST ENVIRONMENT FOR EXPERT SYSTEM

TEST SETUP

INDIVIDUAL TESTS

SCENARIOS

REPEATABLE

RANDOM INPUT

TEST OUTPUT ANALYSIS

HUMAN

REGRESSION BASE

ALTERNATIVE RULE SET

DEFICIENCY DETECTION MECHANISM

DEFICIENCY IN TESTS

DEFICIENCY IN RULESET

DEFICIENCY IN IMPLEMENTATION BASE

OTHER DEFICIENCY



EXPERT SYSTEMS QUALITY CONTROL

QAT-92-2

QUALITY CONTROL ESTIMATES FOR EXPERT SYSTEMS ORDINARY SYSTEMS

METRIC:

DEFECTS PER K LINES OF CODE

LIFE CYCLE ESTIMATES

DESIGN	5-20/kLoc	200-1
CODE	20-40/KLOC	
TEST	20-30/KLOC	20-1
MAINTAIN	10-35/KLoc	10-1
LIFE CYCLE	10-80/KLOC	15-1

EXPERT SYSTEMS

METRIC:

PERCENTAGE OF DEFECTIVE RULES

LIFE CYCLE ESTIMATES

PROTOTYPE	2-5%	400-1
FIRST RELEASE	1-2%	100-1
MAINTAIN	1-4%	20-1
LIFE CYCLE	1-8%	30-1



ADVANCED-CONCEPT MINIMUM ACCEPTANCE CRITERIA

GOAL: MINIMUM ACCEPTANCE CRITERIA FOR SOFTWARE
AT THE UNIT LEVEL

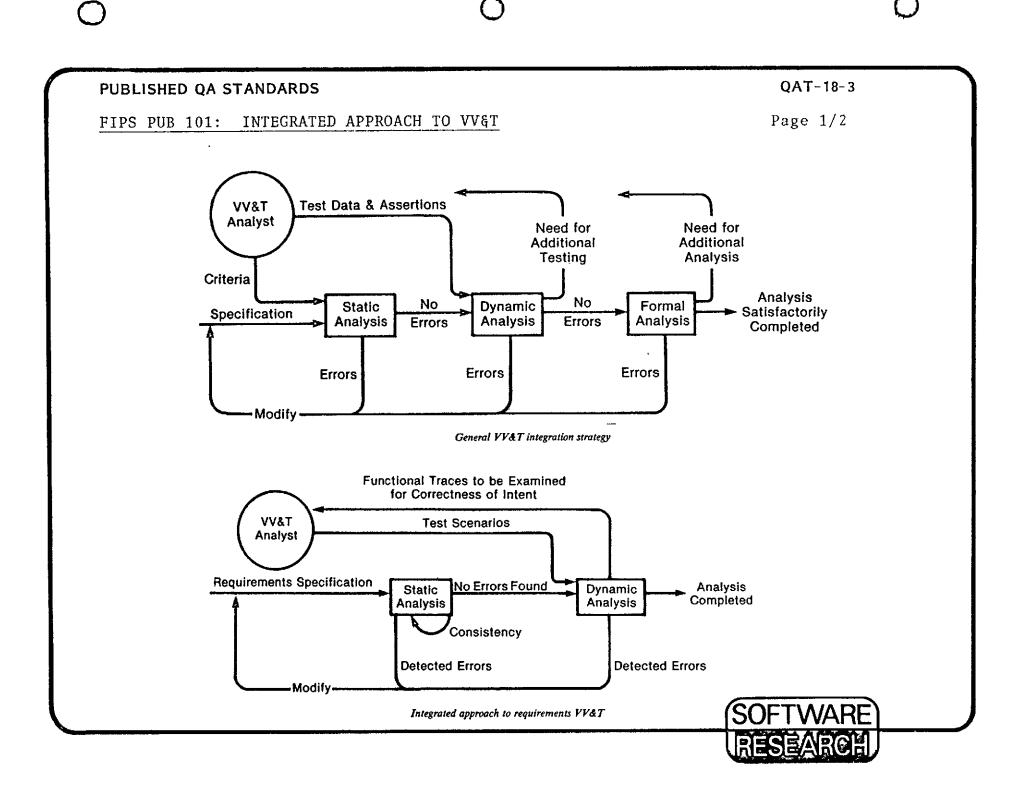
- "BEAUTIFIED" SOURCE PROGRAM LISTING,
 WITH IN-LINE COMMENTING
- OUTPUT FROM STATIC ANALYZER WITH EXPLANATIONS
 AND SUPERVISOR APPROVAL FOR ALL DISCREPANCY
 REPORTS
- OUTPUT FROM TEST EXECUTION VERIFICATION WITH

 MINIMUM TEST COVERAGE GOAL MET, OR EXPLANATIONS

 WITH SUPERVISOR APPROVAL FOR MISSED SEGMENTS
- OUTPUT FROM SOURCE CODE CONTROL SYSTEM SHOWING SUCCESSFUL INTEGRATION OF UNIT WITH "SYSTEM"

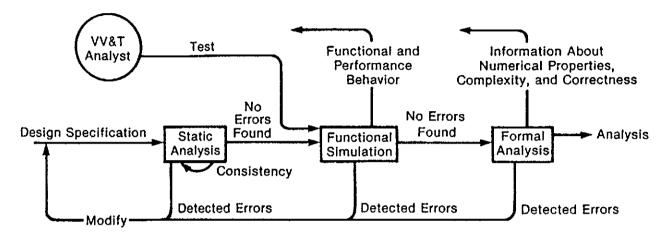
Source: Dr. Bud Wonsiewiez, CompSAC 82, November 1982.



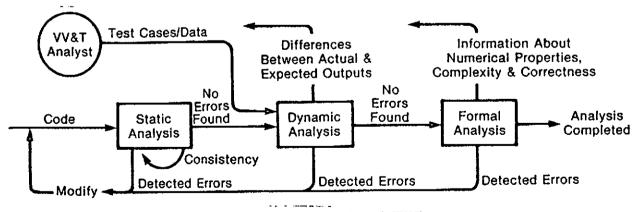


FIPS PUB 101: INTEGRATED APPROACH TO VV&T

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Integrated approach to design VV&T



Integrated approach to code VV&T



FIPS PUB 101: RECOMMENDED APPROACH (BASIC)

Phase	Technique
Requirements	Review
Design	Inspection
Code	Inspection Test Coverage Unit: 100% statement Integration: 100% module call System: 95% module call 100% of major logic paths
Installation	Acceptance Testing: Insure continued validity of system test
Operations and maintenance	For affected code: Inspection Test Coverage: 100% statement 100% module

Recommended techniques for lifecycle VV&T (basic approach)



PUBLISHED QA STANDARDS

QAT-18-6

FIPS PUB 101: RECOMMENDED APPROACH (COMPREHENSIVE)

Phase	Technique
Requirements	Inspection
Design	Interface Analysis Data Flow Analysis
Code	Assertions Standards Audit Interface Analysis Data Flow Analysis Explicit Trace-back of Code to Requirements
Installation	Acceptance Testing
Operations and maintenance	For affected code: Reapply techniques used during development

Recommended techniques for VV&T (comprehensive approach)



PUBLISHED QA STANDARDS

QAT-18-7

FIPS PUB 101: RECOMMENDED APPROACH (CRITICAL)

Phase	Technique	
Requirements	Automated Consistency Analysis	
Design	Automated Consistency Analysis Automated Simulation Proof of Critical Sections	
Code	Symbolic Evaluation Proof of Critical Sections or Properties	
Installation	Acceptance Testing: System Certification	
Operations and maintenance	Re-do proofs that cover affected areas; retest	

Recommended techniques for VV&T for critical software

